

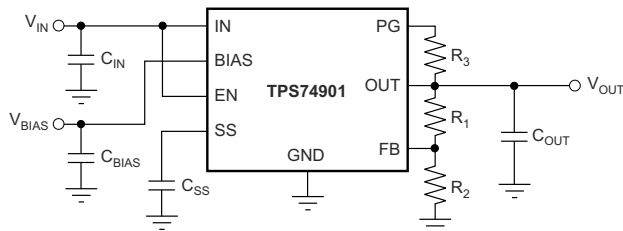
TPS74901 具有可编程软启动功能的 3A 低压降线性稳压器

1 特性

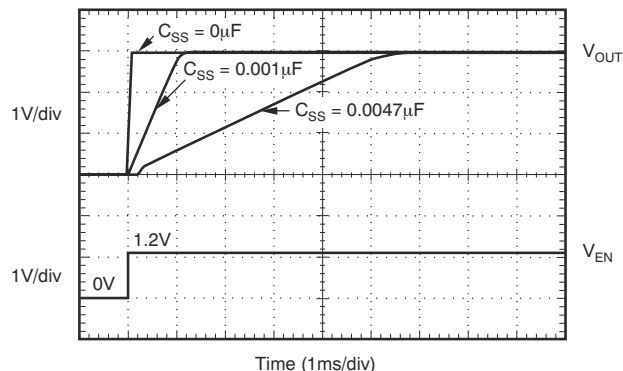
- V_{OUT} 范围：0.8V 至 3.6V
- 超低 V_{IN} 范围：0.8V 至 5.5V
- V_{BIAS} 范围：2.7V 至 5.5V
- 低压降：电压为 3A 时为 120mV (典型值)
- 电源正常 (PG) 输出可实现电源监视或为其他电源提供时序信号
- 整个线路、负载和温度范围内的精度：1% (新芯片)
- 整个线路、负载和温度范围内的精度：2% (旧芯片)
- 可调启动浪涌控制
- V_{BIAS} 支持低 V_{IN} 运行，具有良好的瞬态响应
- 任何输出电容器 $\geq 2.2\mu\text{F}$ 时保持稳定
- 封装：
 - 小型 3mm × 3mm × 1mm VSON
 - 5mm × 5mm × 1mm VQFN 和 DDPAK-7
- 高电平有效使能

2 应用

- 网络附加存储 - 企业级
- 机架式服务器
- 网络接口卡 (NIC)
- 商用网络和服务器 PSU



典型应用电路 (可调节)



导通响应

3 说明

TPS74901 低压降 (LDO) 线性稳压器可面向多种应用提供易于使用的稳健型电源管理解决方案。用户可编程软启动通过减少启动时的容性浪涌电流，更大幅度地减少了输入电源上的应力。软启动具有单调性，旨在为各类处理器和专用集成电路 (ASIC) 供电。借助使能输入和电源正常输出，可通过外部稳压器轻松实现上电排序。凭借全方位的灵活性，该器件可为现场可编程门阵列 (FPGA)、数字信号处理器 (DSP) 等具有特殊启动要求的应用配置可满足其时序要求的解决方案。

该器件还具有高精度的参考电压电路和误差放大器，可在整个负载、线路、温度和过程范围内提供 2% 精度。该器件在使用大于或等于 $2.2\mu\text{F}$ 的任何类型的电容器时都能保持稳定运行，并具有 -40°C 至 $+125^{\circ}\text{C}$ 的额定结温范围。TPS74901 采用小型 3mm × 3mm VQFN 和小型 5mm × 5mm VQFN 封装，可实现高度紧凑的解决方案总尺寸。该器件还可采用 DDPAK-7 封装。

封装信息

器件型号	封装 ⁽¹⁾	封装尺寸 ⁽²⁾
TPS74901	RGW (VQFN , 20)	5mm × 5mm
	KTW (DDPAK/TO-263 , 7)	8.89mm × 10.1mm
	DRC (VSON , 10)	3mm × 3mm

(1) 如需更多信息，请参阅 [机械、封装和可订购信息](#)。

(2) 封装尺寸 (长 × 宽) 为标称值，并包括引脚 (如适用)。



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4 Pin Configuration and Functions

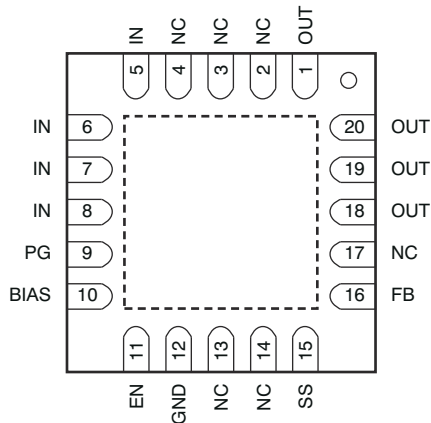


图 4-1. RGW Package, 20-Pin VQFN (Top View)

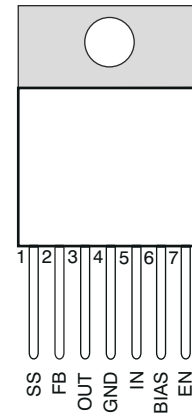


图 4-2. KTW Package (Legacy Chip), 7-Pin DDPAK/TO-263 (Top View)

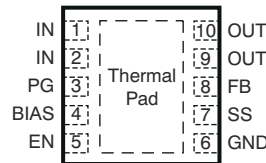


图 4-3. DRC Package, 10-Pin VSON With Thermal Pad (Top View)

表 4-1. Pin Functions

NAME	PIN			TYPE	DESCRIPTION
	DDPAK/TO-263	VQFN	VSON		
BIAS	6	10	4	I	Bias input voltage for error amplifier, reference, and internal control circuits.
EN	7	11	5	I	Enable pin. Driving this pin high enables the regulator. Driving this pin low puts the regulator into shutdown mode. This pin must not be left floating.
FB	2	16	8	I	This pin is the feedback connection to the center tap of an external resistor divider network that sets the output voltage. This pin must not be left floating.
GND	4	12	6	—	Ground
IN	5	5, 6, 7, 8	1, 2	I	Unregulated input to the device.
NC	—	2, 3, 4, 13, 14, 17	—	—	No connection. This pin can be left floating or connected to GND to allow better thermal contact to the top-side plane.
OUT	3	1, 18, 19, 20	9, 10	O	Regulated output voltage. A small capacitor (total typical capacitance $\geq 2.2\mu\text{F}$, ceramic) is needed from this pin to ground to assure stability.
PG	—	9	3	O	Power-good (PG) is an open-drain, active-high output that indicates the status of V_{OUT} . When V_{OUT} exceeds the PG trip threshold, the PG pin goes into a high-impedance state. When V_{OUT} is below this threshold the pin is driven to a low-impedance state. A pullup resistor from $10\text{k}\Omega$ to $1\text{M}\Omega$ must be connected from this pin to a supply up to 5.5V. The supply can be higher than the input voltage. Alternatively, the PG pin can be left floating if output monitoring is not necessary.
SS	1	15	7	—	Soft-start pin. A capacitor connected on this pin to ground sets the start-up time. If this pin is left floating, the regulator output soft-start ramp time is typically $100\mu\text{s}$.
Thermal Pad	—	—	—	—	Solder to the ground plane for increased thermal performance.

5 Specifications

5.1 Absolute Maximum Ratings

over operating temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
V_{IN} , V_{BIAS}	Input voltage	- 0.3	6	V
V_{EN}	Enable voltage	- 0.3	6	V
V_{PG}	Power-good voltage	- 0.3	6	V
I_{PG}	PG sink current	0	1.5	mA
V_{SS}	Soft-start voltage	- 0.3	6	V
V_{FB}	Feedback voltage	- 0.3	6	V
V_{OUT}	Output voltage	- 0.3	$V_{IN} + 0.3$	V
I_{OUT}	Maximum output current	Internally limited		
	Output short-circuit duration	Indefinite		
P_{DISS}	Continuous total power dissipation	See Thermal Information		
T_J	Junction Temperature	- 40	150	°C
T_{stg}	Storage Temperature	- 55	150	

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±2000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±500	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
 (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_{IN}	Input supply voltage	$V_{OUT} + V_{DO}$ (V_{IN})		5.5	V
V_{EN}	Enable supply voltage			5.5	V
V_{BIAS} ⁽¹⁾	BIAS supply voltage	$V_{OUT} + V_{DO}$ (V_{BIAS}) ⁽²⁾		5.5	V
V_{OUT}	Output voltage	0.8		3.6	V
I_{OUT}	Output current	0		3	A
C_{OUT}	Output capacitor	2.2			μF
C_{IN}	Input capacitor ⁽³⁾	1			μF
C_{BIAS}	Bias capacitor	0.1	1		μF
T_J	Operating junction temperature	- 40		125	°C

- (1) BIAS supply is required when V_{IN} is below $V_{OUT} + 1.62$ V.
 (2) V_{BIAS} has a minimum voltage of 2.7 V or $V_{OUT} + V_{DO}$ (V_{BIAS}), whichever is higher.
 (3) If V_{IN} and V_{BIAS} are connected to the same supply, the recommended minimum capacitor for the supply is 4.7 μF.

5.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TPS749					UNIT
		RGW (VQFN)	RGW (VQFN) ⁽²⁾	KTW (TO-263)	DRC (VSON)	DRC (VSON) ⁽²⁾	
		20 PINS	20 PINS	7 PINS	10 PINS	10 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	38.1	34.7	33.8	48.1	47.2	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	36.3	31	35.9	60.3	63.7	°C/W
R _{θJB}	Junction-to-board thermal resistance	17.5	13.5	25	22.4	19.5	°C/W
ψ _{JT}	Junction-to-top characterization parameter	0.7	1.4	6	1.0	4.2	°C/W
ψ _{JB}	Junction-to-board characterization parameter	17.6	13.5	23.6	22.6	19.4	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	6.2	3.6	N/A	4.3	3.3	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC package thermal metrics application report](#).
(2) New Chip.

5.5 Electrical Characteristics

at V_{EN} = 1.1 V, V_{IN} = V_{OUT} + 0.3 V, C_{BIAS} = 0.1 μF, C_{IN} = C_{OUT} = 10 μF, C_{NR} = 1 nF, I_{OUT} = 50 mA, V_{BIAS} = 5.0 V, and T_J = -40°C to 125°C, (unless otherwise noted); typical values are at T_J = 25°C

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{REF}	Internal reference (Adj.)	T _A = +25°C	0.798	0.802	0.806	V
V _{OUT}	Output voltage range	V _{IN} = 5V, I _{OUT} = 3A	V _{REF}		3.6	V
V _{OUT}	Accuracy (RGW and SON packages) ⁽¹⁾	V _{OUT} + 2.2V ≤ V _{BIAS} ≤ 5.5 V, 50mA ≤ I _{OUT} ≤ 3A (Legacy Chip)	- 2	±0.5	2	%
		V _{OUT} + 2.2V ≤ V _{BIAS} ≤ 5.5V, 50mA ≤ I _{OUT} ≤ 3A (New Chip)	- 1	±0.3	1	
	Accuracy (KTW package) ⁽¹⁾	V _{OUT} + 2.4V ≤ V _{BIAS} ≤ 5.5V, 50mA ≤ I _{OUT} ≤ 3A (Legacy Chip Only)	- 2	±0.5	2	
Δ V _{OUT} (Δ V _{IN})	Line regulation	V _{OUT(nom)} + 0.3 ≤ V _{IN} ≤ 5.5V (Legacy Chip)		0.03		% / V
		V _{OUT(nom)} + 0.3 ≤ V _{IN} ≤ 5.5V (New Chip)		0.001		
Δ V _{OUT} (Δ I _{OUT})	Load regulation	50mA ≤ I _{OUT} ≤ 3A		0.09		% / A
V _{DO}	V _{IN} dropout voltage ⁽²⁾	I _{OUT} = 3A, V _{BIAS} - V _{OUT(nom)} ≥ 3.25V ⁽³⁾ (Legacy Chip)		120	280	mV
		I _{OUT} = 3A, V _{BIAS} - V _{OUT(nom)} ≥ 3.25V ⁽³⁾ (New Chip)		120	200	
	V _{BIAS} dropout voltage ⁽²⁾	I _{OUT} = 3A, V _{IN} = V _{BIAS} (Legacy Chip)		1.31	1.75	V
		I _{OUT} = 3A, V _{IN} = V _{BIAS} (New Chip)		1.45	1.6	
I _{CL}	Current limit	V _{OUT} = 80% × V _{OUT(nom)} , RGW Package	3.9	4.6	5.5	A
		V _{OUT} = 80% × V _{OUT(nom)} , KTW Package	3.8	4.6	5.5	
I _{BIAS}	BIAS pin current	Legacy Chip		1	2	mA
		New Chip		1	1.2	

5.5 Electrical Characteristics (续)

at $V_{EN} = 1.1\text{ V}$, $V_{IN} = V_{OUT} + 0.3\text{ V}$, $C_{BIAS} = 0.1\text{ }\mu\text{F}$, $C_{IN} = C_{OUT} = 10\text{ }\mu\text{F}$, $C_{NR} = 1\text{ nF}$, $I_{OUT} = 50\text{ mA}$, $V_{BIAS} = 5.0\text{ V}$, and $T_J = -40^\circ\text{C}$ to 125°C , (unless otherwise noted); typical values are at $T_J = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I_{SHDN}	Shutdown supply current (I_{GND})	$V_{EN} \leq 0.4\text{ V}$ (Legacy Chip)		1	50	μA
I_{SHDN} (smart enable)		$V_{EN} \leq 0.4\text{ V}$, $V_{IN} = V_{BIAS} = 5.5\text{ V}$ (New Chip)		0.85	2.75	
I_{FB}	Feedback pin current	Legacy Chip	- 1	0.15	1	μA
		New Chip	- 30	0.15	30	nA
PSRR	Power-supply rejection (V_{IN} to V_{OUT})	1 kHz, $I_{OUT} = 1.5\text{ A}$, $V_{IN} = 1.8\text{ V}$, $V_{OUT} = 1.5\text{ V}$		60		dB
		300 kHz, $I_{OUT} = 1.5\text{ A}$, $V_{IN} = 1.8\text{ V}$, $V_{OUT} = 1.5\text{ V}$		30		
	Power-supply rejection (V_{BIAS} to V_{OUT})	1 kHz, $I_{OUT} = 1.5\text{ A}$, $V_{IN} = 1.8\text{ V}$, $V_{OUT} = 1.5\text{ V}$ (Legacy Chip)		50		dB
		1 kHz, $I_{OUT} = 1.5\text{ A}$, $V_{IN} = 1.8\text{ V}$, $V_{OUT} = 1.5\text{ V}$ (New Chip)		57		
		300 kHz, $I_{OUT} = 1.5\text{ A}$, $V_{IN} = 1.8\text{ V}$, $V_{OUT} = 1.5\text{ V}$ (Legacy Chip)		30		
		300 kHz, $I_{OUT} = 1.5\text{ A}$, $V_{IN} = 1.8\text{ V}$, $V_{OUT} = 1.5\text{ V}$ (New Chip)		49		
V_n	Output noise voltage	BW = 100 Hz to 100 kHz, $I_{OUT} = 3\text{ A}$, $C_{SS} = 1\text{ nF}$ (Legacy Chip)		25		$\mu\text{V}_{rms} \times V_{out}$
		BW = 100 Hz to 100 kHz, $I_{OUT} = 3\text{ A}$, $C_{SS} = 1\text{ nF}$ (New Chip)		20		
t_{STR}	Minimum start-up time	R_{LOAD} for $I_{OUT} = 1\text{ A}$, $C_{SS} = \text{open}$ (Legacy Chip)		200		μs
		R_{LOAD} for $I_{OUT} = 1\text{ A}$, $C_{SS} = \text{open}$ (New Chip)		250		
I_{SS}	Soft-start charging current	$V_{SS} = 0.4\text{ V}$ (Legacy Chip)		440		nA
		$V_{SS} = 0.4\text{ V}$ (New Chip)		530		
$V_{EN(hi)}$	Enable input high level		1.1		5.5	V
$V_{EN(lo)}$	Enable input low level		0		0.4	V
$V_{EN(hys)}$	Enable pin hysteresis			50		mV
$V_{EN(dg)}$	Enable pin deglitch time			20		μs
I_{EN}	Enable pin current	$V_{EN} = 5\text{ V}$ (Legacy Chip)		0.1	1	μA
		$V_{EN} = 5\text{ V}$ (New Chip)		0.1	0.25	
V_{IT}	PG trip threshold	V_{OUT} decreasing	85	90	94	% V_{OUT}
V_{HYS}	PG trip hysteresis			3		
$V_{PG(lo)}$	PG output low voltage	$I_{PG} = 1\text{ mA}$ (sinking), $V_{OUT} < V_{IT}$ (Legacy Chip)			0.3	V
		$I_{PG} = 1\text{ mA}$ (sinking), $V_{OUT} < V_{IT}$ (New Chip)			0.12	
$I_{PG(lkg)}$	PG leakage current	$V_{PG} = 5.25\text{ V}$, $V_{OUT} > V_{IT}$ (Legacy Chip)		0.1	1	μA
		$V_{PG} = 5.25\text{ V}$, $V_{OUT} > V_{IT}$ (New Chip)		0.001	0.05	
T_J	Operating junction temperature		- 40		125	$^\circ\text{C}$

5.5 Electrical Characteristics (续)

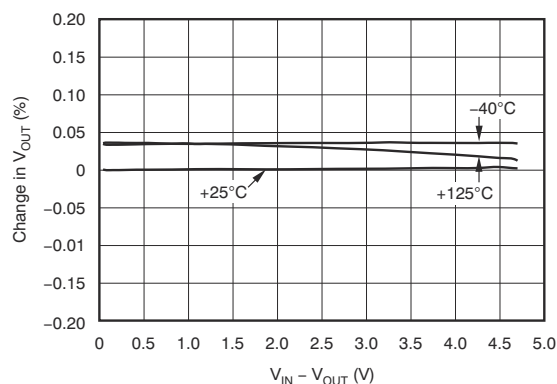
at $V_{EN} = 1.1\text{ V}$, $V_{IN} = V_{OUT} + 0.3\text{ V}$, $C_{BIAS} = 0.1\text{ }\mu\text{F}$, $C_{IN} = C_{OUT} = 10\text{ }\mu\text{F}$, $C_{NR} = 1\text{ nF}$, $I_{OUT} = 50\text{ mA}$, $V_{BIAS} = 5.0\text{ V}$, and $T_J = -40^\circ\text{C}$ to 125°C , (unless otherwise noted); typical values are at $T_J = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
T_{SD}	Thermal shutdown temperature	Shutdown, temperature increasing		165		$^\circ\text{C}$
		Reset, temperature decreasing		140		
$R_{PULLDOWN}$		$V_{BIAS} = 5\text{ V}$, $V_{EN} = 0\text{ V}$		0.83		$\text{k}\Omega$

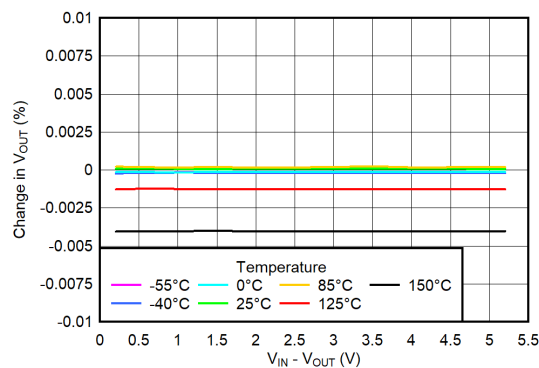
- (1) Adjustable devices tested at 0.8 V; resistor tolerance is not taken into account.
- (2) Dropout is defined as the voltage from V_{IN} to V_{OUT} when V_{OUT} is 3% below nominal.
- (3) 3.25 V is a test condition of this device and can be adjusted by referring to Figure 5-11.

5.6 Typical Characteristics: $I_{OUT} = 50\text{mA}$

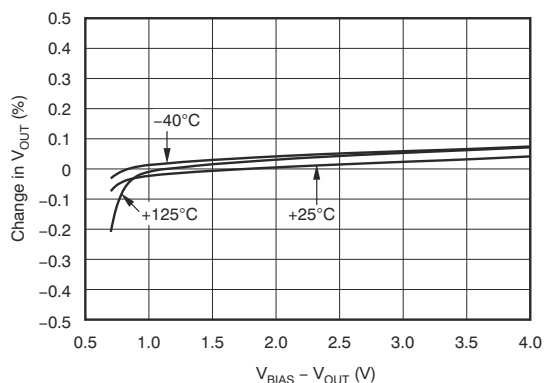
at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 0.3\text{V}$, $V_{BIAS} = 5\text{V}$, $I_{OUT} = 50\text{mA}$, $V_{EN} = V_{IN}$, $C_{IN} = 1\mu\text{F}$, $C_{BIAS} = 4.7\mu\text{F}$, and $C_{OUT} = 10\mu\text{F}$ (unless otherwise noted)



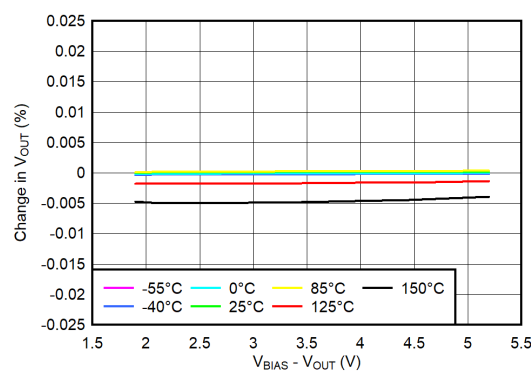
Legacy chip

图 5-1. V_{IN} Line Regulation

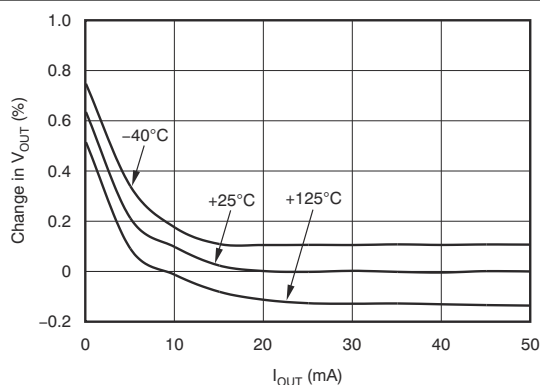
New chip

图 5-2. V_{IN} Line Regulation

Legacy chip

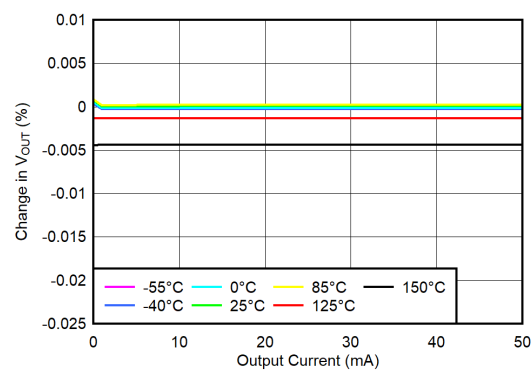
图 5-3. V_{BIAS} Line Regulation

New chip

图 5-4. V_{BIAS} Line Regulation

Legacy chip

图 5-5. Load Regulation at Light Load

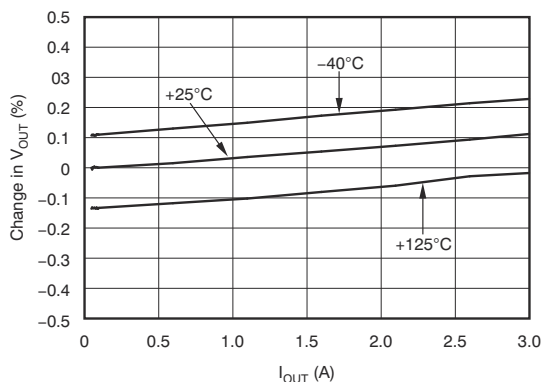


New chip

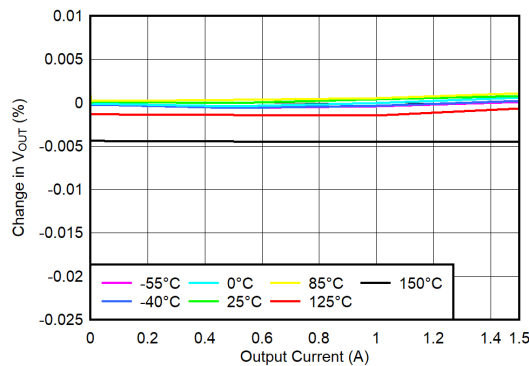
图 5-6. Load Regulation at Light Load

5.6 Typical Characteristics: $I_{OUT} = 50\text{mA}$ (continued)

at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 0.3\text{V}$, $V_{BIAS} = 5\text{V}$, $I_{OUT} = 50\text{mA}$, $V_{EN} = V_{IN}$, $C_{IN} = 1\mu\text{F}$, $C_{BIAS} = 4.7\mu\text{F}$, and $C_{OUT} = 10\mu\text{F}$ (unless otherwise noted)



Legacy chip
图 5-7. Load Regulation



New chip
图 5-8. Load Regulation

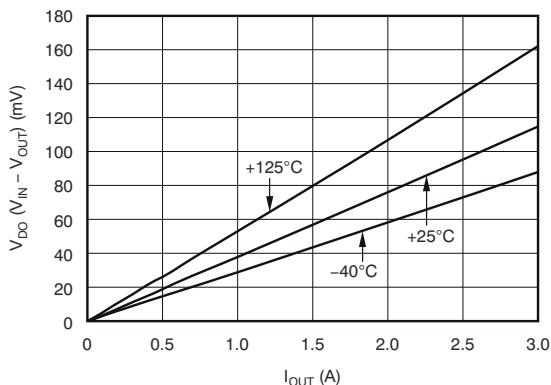


图 5-9. V_{IN} Dropout Voltage vs I_{OUT} and Temperature (T_J)

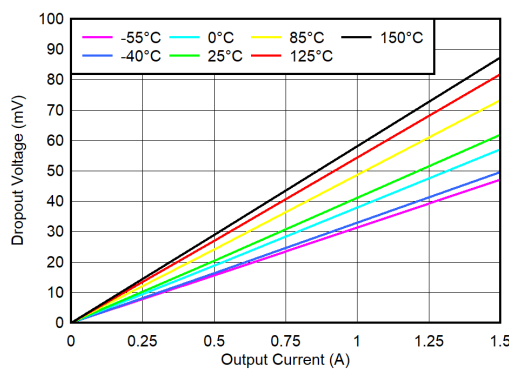


图 5-10. V_{IN} Dropout Voltage vs I_{OUT} and Temperature (T_J)

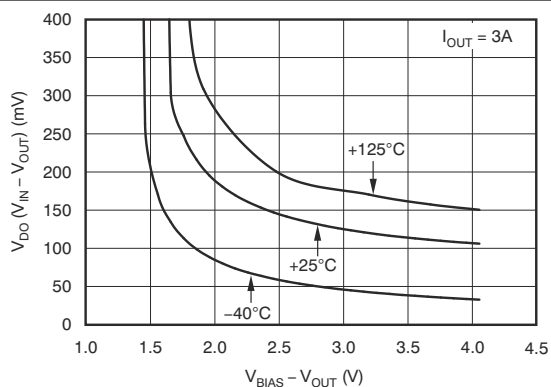


图 5-11. V_{IN} Dropout Voltage vs V_{IN} Dropout Voltage vs I_{OUT} and Temperature (T_J)

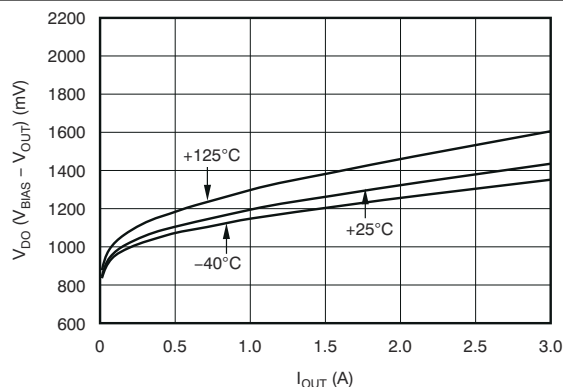


图 5-12. V_{BIAS} Dropout Voltage vs I_{OUT} and Temperature (T_J)

5.6 Typical Characteristics: $I_{OUT} = 50\text{mA}$ (continued)

at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 0.3\text{V}$, $V_{BIAS} = 5\text{V}$, $I_{OUT} = 50\text{mA}$, $V_{EN} = V_{IN}$, $C_{IN} = 1\mu\text{F}$, $C_{BIAS} = 4.7\mu\text{F}$, and $C_{OUT} = 10\mu\text{F}$ (unless otherwise noted)

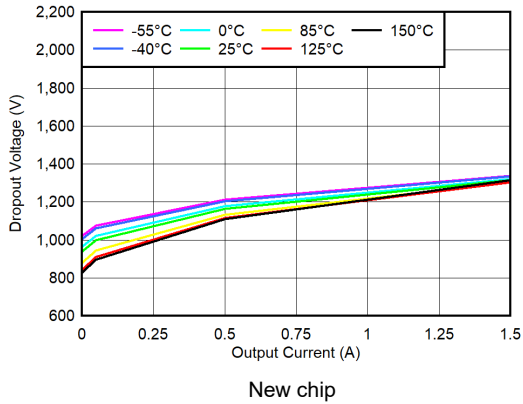


图 5-13. V_{BIAS} Dropout Voltage vs I_{OUT} and Temperature (T_J)

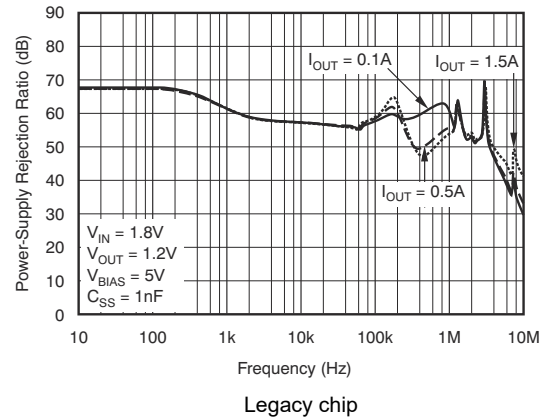


图 5-14. V_{BIAS} PSRR vs Frequency

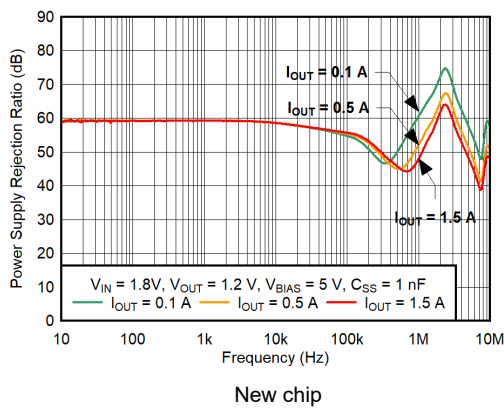


图 5-15. V_{BIAS} PSRR vs Frequency

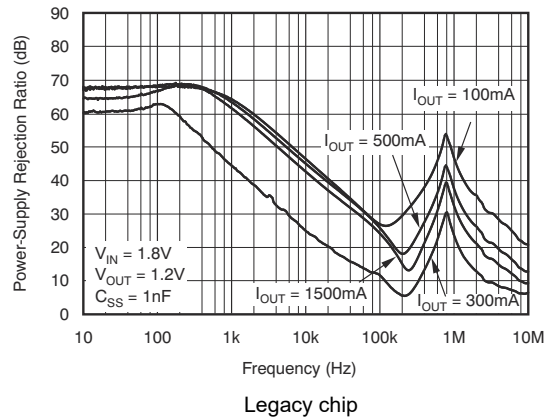


图 5-16. V_{IN} PSRR vs Frequency

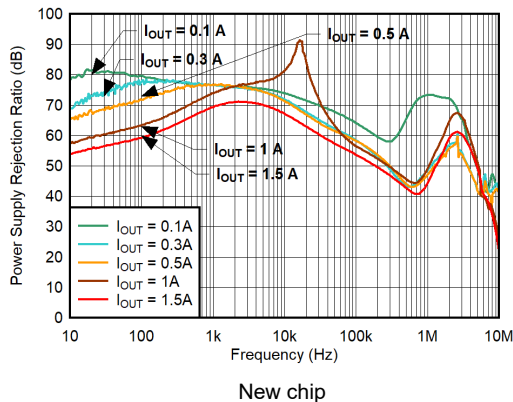


图 5-17. V_{IN} PSRR vs Frequency

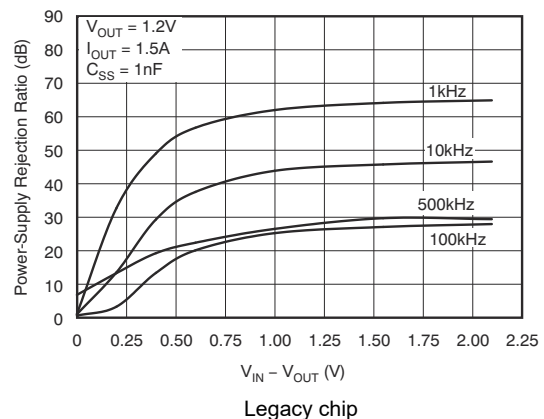


图 5-18. V_{IN} PSRR vs ($V_{IN} - V_{OUT}$)

5.6 Typical Characteristics: $I_{OUT} = 50\text{mA}$ (continued)

at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 0.3\text{V}$, $V_{BIAS} = 5\text{V}$, $I_{OUT} = 50\text{mA}$, $V_{EN} = V_{IN}$, $C_{IN} = 1\mu\text{F}$, $C_{BIAS} = 4.7\mu\text{F}$, and $C_{OUT} = 10\mu\text{F}$ (unless otherwise noted)

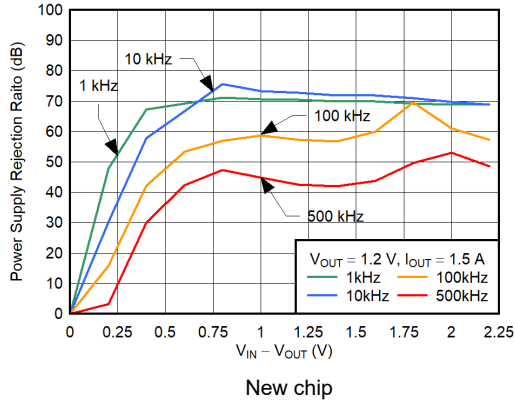


图 5-19. V_{IN} PSRR vs $(V_{IN} - V_{OUT})$

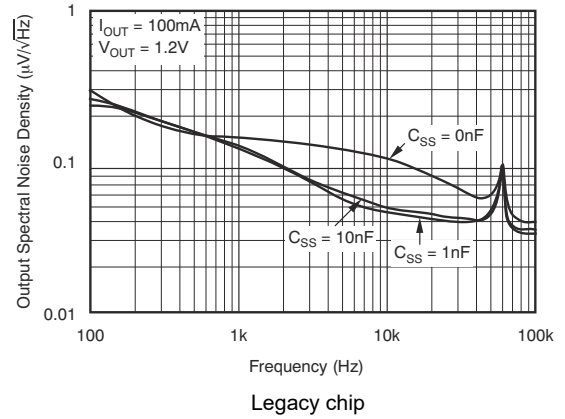


图 5-20. Noise Spectral Density

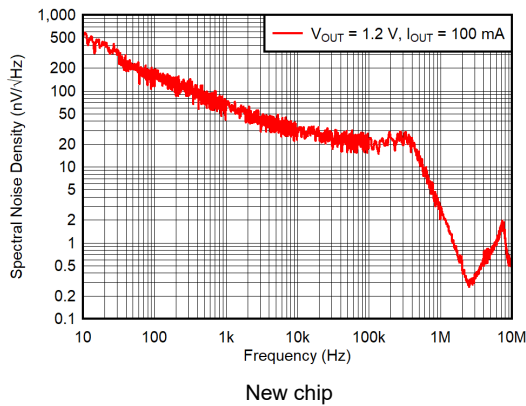


图 5-21. Noise Spectral Density

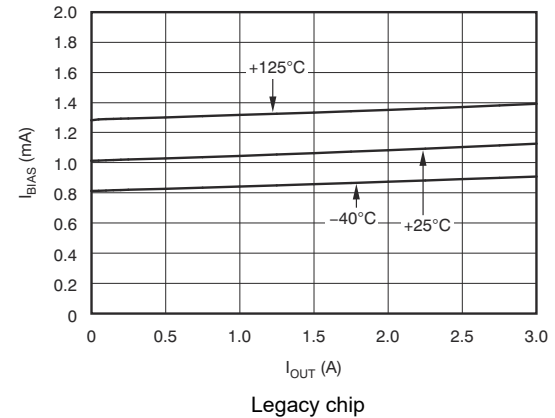


图 5-22. BIAS Pin Current vs I_{OUT} and Temperature (T_J)

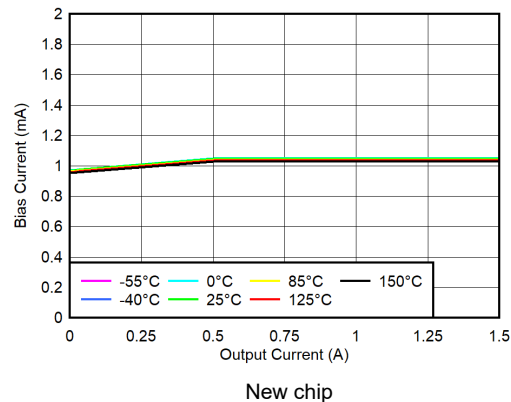


图 5-23. BIAS Pin Current vs Output Current and Temperature (T_J)

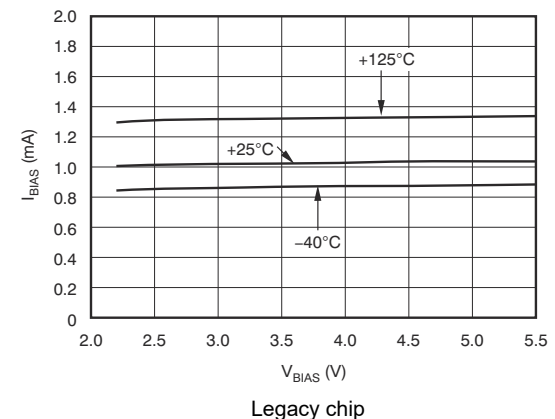


图 5-24. BIAS Pin Current vs V_{BIAS} and Temperature (T_J)

5.6 Typical Characteristics: $I_{OUT} = 50\text{mA}$ (continued)

at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 0.3\text{V}$, $V_{BIAS} = 5\text{V}$, $I_{OUT} = 50\text{mA}$, $V_{EN} = V_{IN}$, $C_{IN} = 1\mu\text{F}$, $C_{BIAS} = 4.7\mu\text{F}$, and $C_{OUT} = 10\mu\text{F}$ (unless otherwise noted)

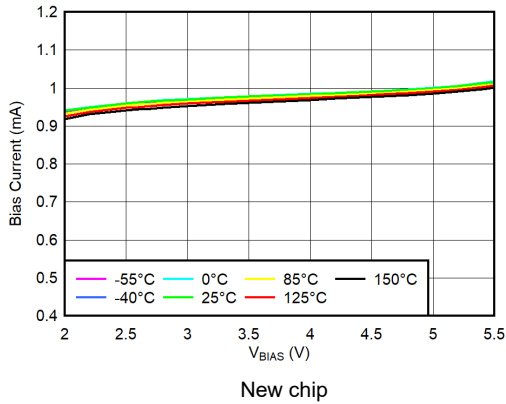


图 5-25. BIAS Pin Current vs V_{BIAS} and Temperature (T_J)

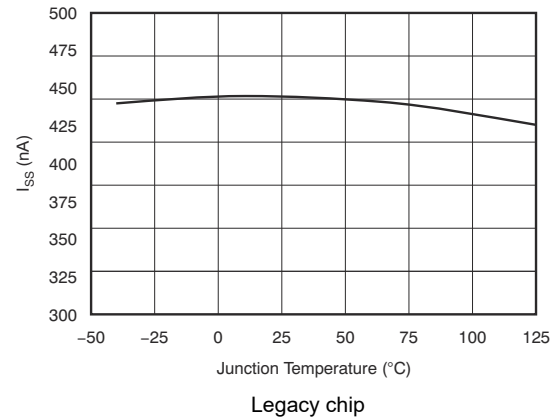


图 5-26. Soft-Start Charging Current (I_{SS}) vs Temperature (T_J)

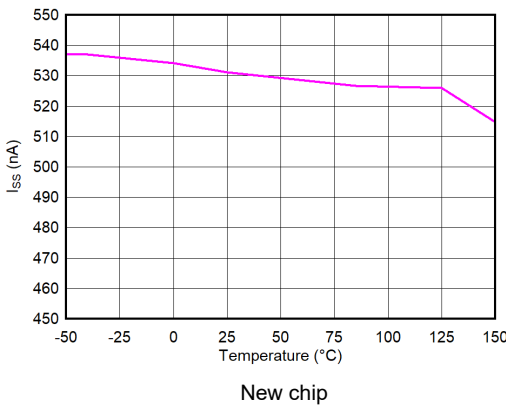


图 5-27. Soft-Start Charging Current (I_{SS}) vs Temperature (T_J)

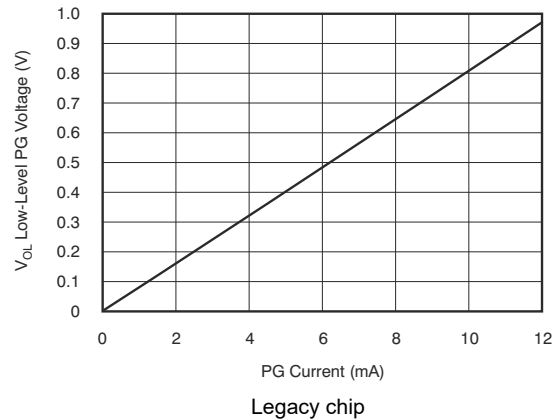


图 5-28. Low-Level PG Voltage vs Current

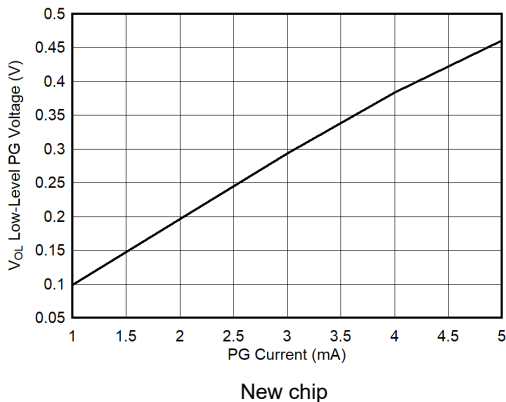


图 5-29. Low-Level PG Voltage vs Current

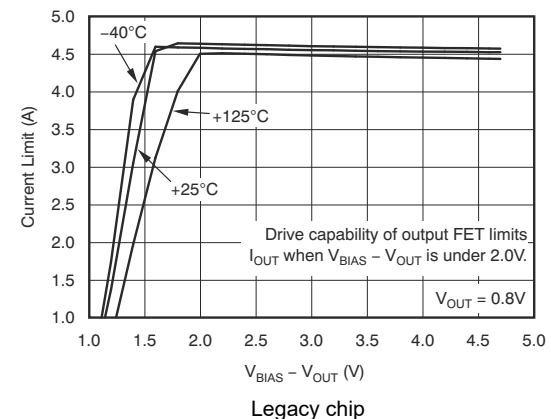


图 5-30. Current Limit vs ($V_{BIAS} - V_{OUT}$)

5.6 Typical Characteristics: $I_{OUT} = 50\text{mA}$ (continued)

at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 0.3\text{V}$, $V_{BIAS} = 5\text{V}$, $I_{OUT} = 50\text{mA}$, $V_{EN} = V_{IN}$, $C_{IN} = 1\mu\text{F}$, $C_{BIAS} = 4.7\mu\text{F}$, and $C_{OUT} = 10\mu\text{F}$ (unless otherwise noted)

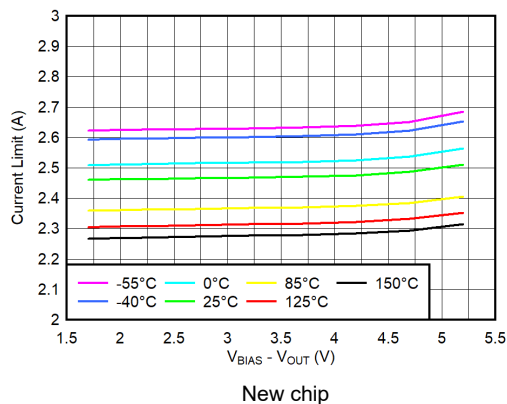


图 5-31. Current Limit vs ($V_{BIAS} - V_{OUT}$)

5.7 Typical Characteristics: $I_{OUT} = 1\text{ A}$

at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 0.3\text{ V}$, $V_{BIAS} = 5\text{ V}$, $I_{OUT} = 1\text{ A}$, $V_{EN} = V_{IN} = 1.8\text{ V}$, $V_{OUT} = 1.5\text{ V}$, $C_{IN} = 1\mu\text{F}$, $C_{BIAS} = 4.7\mu\text{F}$, and $C_{OUT} = 10\mu\text{F}$ (unless otherwise noted)

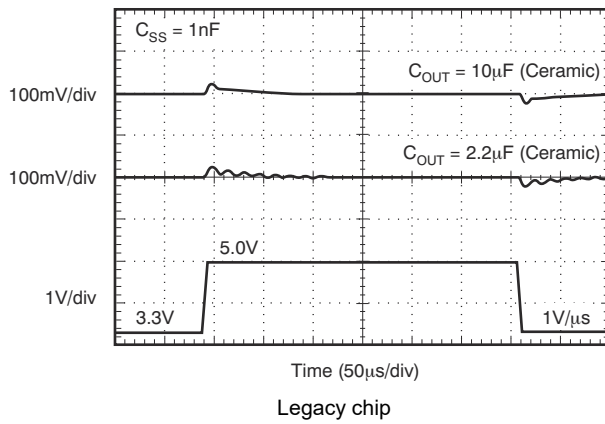
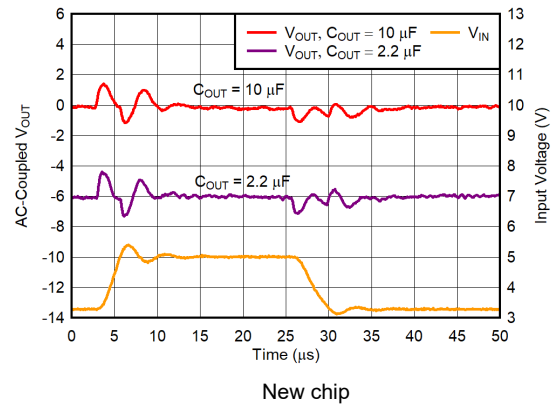
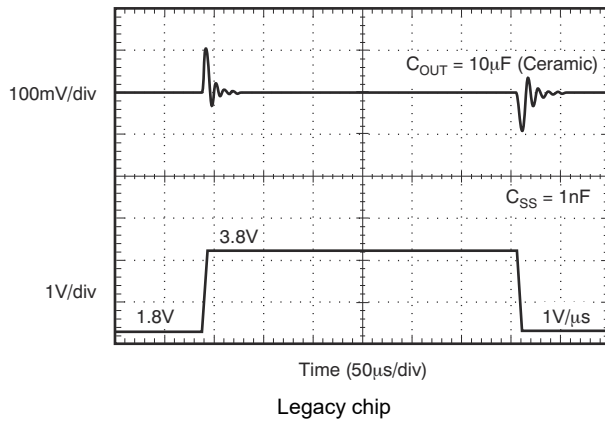
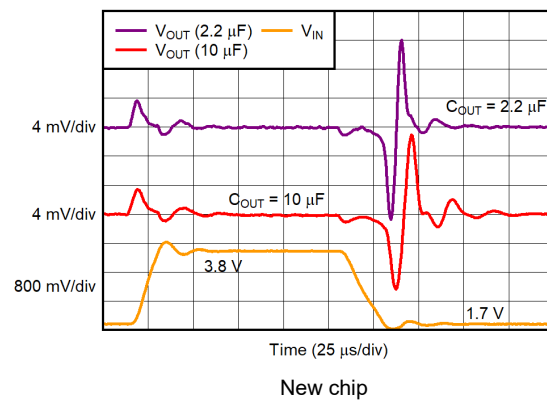
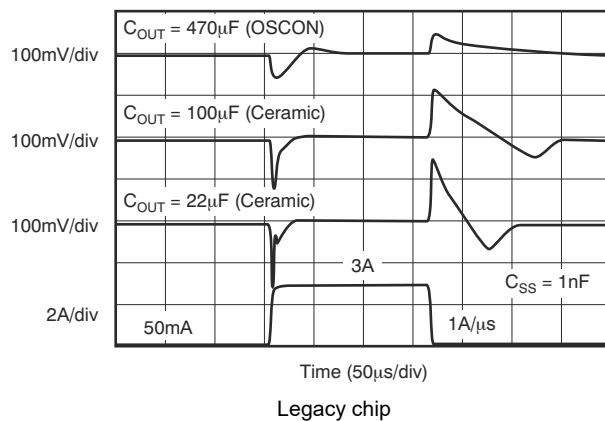
图 5-32. V_{BIAS} Line Transient图 5-33. V_{BIAS} Line Transient图 5-34. V_{IN} Line Transient图 5-35. V_{IN} Line Transient

图 5-36. Output Load Transient Response

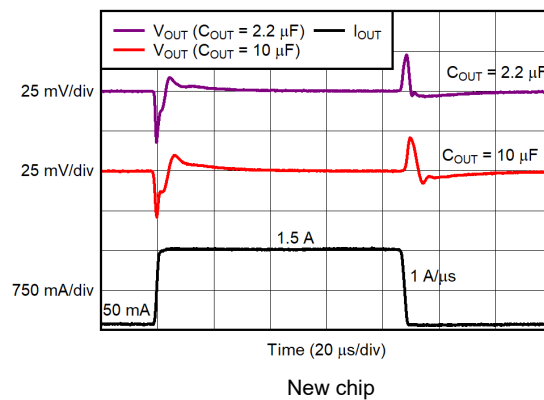


图 5-37. Output Load Transient Response

5.7 Typical Characteristics: $I_{OUT} = 1\text{ A}$ (continued)

at $T_J = 25^\circ\text{C}$, $V_{IN} = V_{OUT(NOM)} + 0.3\text{V}$, $V_{BIAS} = 5\text{V}$, $I_{OUT} = 1\text{A}$, $V_{EN} = V_{IN} = 1.8\text{V}$, $V_{OUT} = 1.5\text{V}$, $C_{IN} = 1\mu\text{F}$, $C_{BIAS} = 4.7\mu\text{F}$, and $C_{OUT} = 10\mu\text{F}$ (unless otherwise noted)

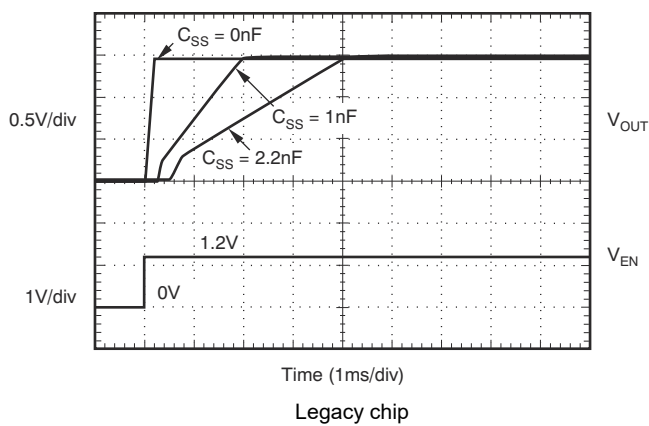


图 5-38. Turn-On Response

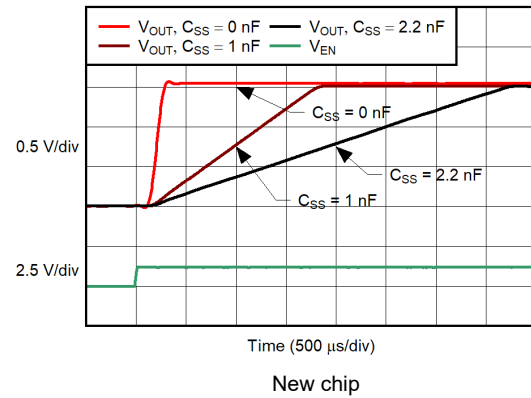


图 5-39. Turn-On Response

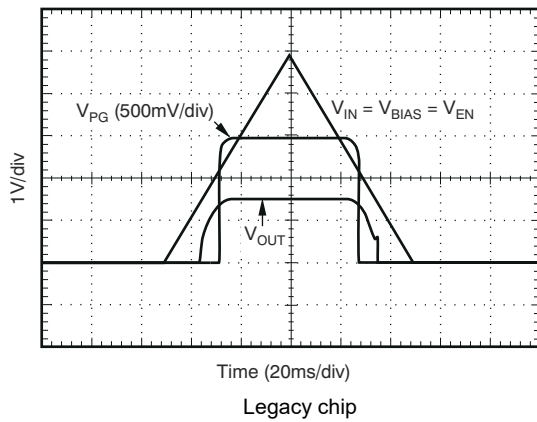


图 5-40. Power-Up and Power-Down

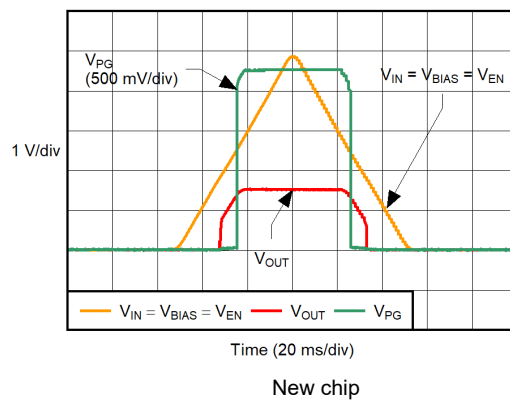


图 5-41. Power-Up, Power-Down

6 Detailed Description

6.1 Overview

The TPS74901 is a low-dropout (LDO) regulator that features soft-start capabilities. This regulator uses a low-current bias input to power all internal control circuitry, allowing the NMOS pass transistor to regulate very-low input and output voltages.

Using an NMOS pass transistor offers several critical advantages for many applications. Unlike a p-channel metal-oxide-semiconductor field effect transistor (PMOS) topology device, the output capacitor has little effect on loop stability. This architecture allows the TPS74901 to be stable with any capacitor with a value of $2.2\mu\text{F}$ or greater. Transient response is also superior to PMOS topologies, particularly for low V_{IN} applications.

The TPS74901 features a programmable voltage-controlled soft-start circuit that provides a smooth, monotonic start-up and limits start-up inrush currents that can be caused by large capacitive loads. A power-good (PG) output is available to allow supply monitoring and sequencing of other supplies. An enable (EN) pin with hysteresis and deglitch allows slow-ramping signals to be used for sequencing the device. The low V_{IN} and V_{OUT} capability allows for inexpensive, easy-to-design, and efficient linear regulation between the multiple supply voltages often present in processor-intensive systems.

6.2 Functional Block Diagrams

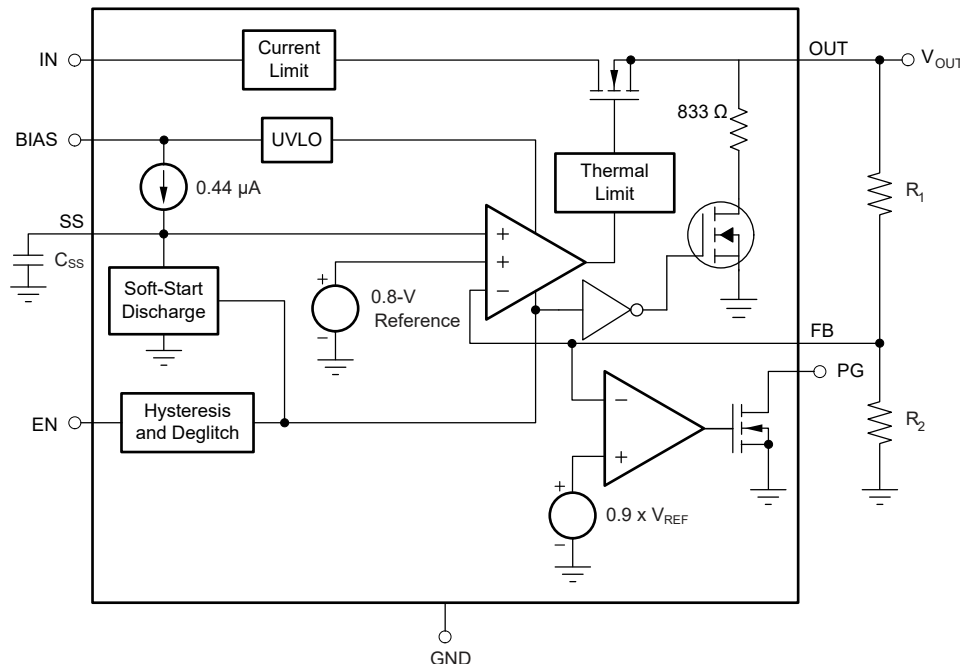


图 6-1. Legacy Chip Functional Block Diagram

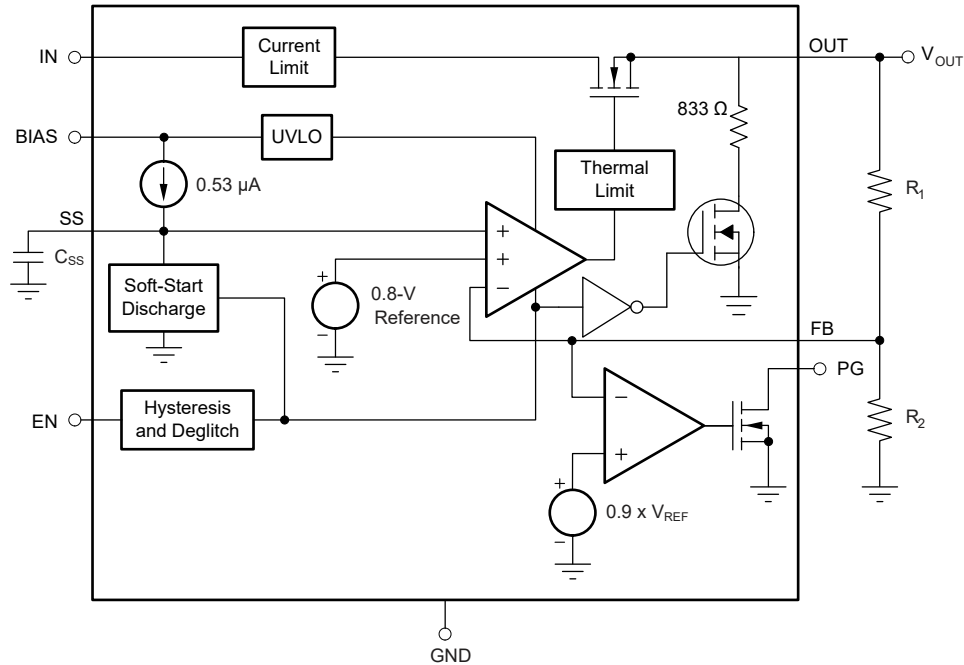


图 6-2. New Chip Functional Block Diagram

6.3 Feature Description

6.3.1 Enable and Shutdown

The enable (EN) pin is active high and is compatible with standard digital-signaling levels. V_{EN} below 0.4V turns the regulator off and V_{EN} above 1.1V turns the regulator on. Unlike many regulators, the enable circuitry has hysteresis and deglitching for use with relatively slowly ramping analog signals. This configuration allows the TPS74901 to be enabled by connecting the output of another supply to the EN pin. The enable circuitry typically has 50mV of hysteresis and a deglitch circuit to help avoid ON-OFF cycling because of small glitches in the V_{EN} signal.

The enable threshold is typically 0.8V and varies with temperature and process variations. Temperature variation is approximately $-1\text{mV}/^{\circ}\text{C}$; process variation accounts for most of the rest of the variation to the 0.4V and 1.1V limits. If precise turn-on timing is required, a fast rise-time signal must be used to enable the TPS74901.

If not used, EN can be connected to either IN or BIAS. If EN is connected to IN, then connect EN as close as possible to the largest capacitance on the input to prevent voltage droops on that line from triggering the enable circuit.

The TPS749 has an internal active pulldown circuit that connects the output to GND through an $833\ \Omega$ resistor when the device is disabled. This resistor discharges the output with a time constant of:

$$\tau = \left(\frac{833 \times R_L}{833 + R_L} \right) \times C_{OUT}$$

6.3.2 Power-Good

The power-good (PG) pin is an open-drain output and can be connected to any 5.5V or lower rail through an external pullup resistor. This pin requires at least 1.1V on V_{BIAS} to have a valid output. The PG output is high-impedance when V_{OUT} is greater than $V_{IT} + V_{HYS}$. If V_{OUT} drops below V_{IT} or if V_{BIAS} drops below 1.9V, the open-drain output turns on and pulls the PG output low. The PG pin also asserts when the device is disabled. The recommended operating condition of PG pin sink current is up to 1mA, so the pullup resistor for PG must be in the range of 10k Ω to 1M Ω . PG is only provided on the VQFN package. If output voltage monitoring is not needed, the PG pin can be left floating.

6.3.3 Internal Current Limit

The TPS74901 features a factory-trimmed, accurate current limit that is flat over temperature and supply voltage. The current limit allows the device to supply surges of up to 4A and maintain regulation. The current limit responds in approximately 10 μ s to reduce the current during a short-circuit fault.

The internal current-limit protection circuitry of the TPS74901 is designed to protect against overload conditions. This circuitry is not intended to allow operation above the rated current of the device. Continuously running the TPS74901 above the rated current degrades device reliability.

6.3.4 Thermal Protection

Thermal protection disables the output when the junction temperature rises to approximately 160°C, allowing the device to cool. When the junction temperature cools to approximately 140°C, the output circuitry is enabled. Depending on power dissipation, thermal resistance, and ambient temperature the thermal protection circuit can cycle on and off. This cycling limits the dissipation of the regulator, protecting the regulator from damage as a result of overheating.

Activation of the thermal protection circuit indicates excessive power dissipation or inadequate heat sinking. For reliable operation, junction temperature must be limited to 125°C maximum. To estimate the margin of safety in a complete design (including heat sink), increase the ambient temperature until thermal protection is triggered; use worst-case loads and signal conditions. For good reliability, thermal protection must trigger at least 40°C above the maximum expected ambient condition of the application. This condition produces a worst-case junction temperature of 125°C at the highest expected ambient temperature and worst-case load.

The internal protection circuitry of the TPS74901 is designed to protect against overload conditions. This circuitry is not intended to replace proper heat sinking. Continuously running the TPS74901 into thermal shutdown degrades device reliability.

6.4 Device Functional Modes

表 6-1 lists the conditions that lead to the different modes of operation.

表 6-1. Device Functional Mode Comparison

OPERATING MODE	PARAMETER				
	V_{IN}	V_{EN}	V_{BIAS}	I_{OUT}	T_J
Normal mode	$V_{IN} > V_{OUT(nom)} + V_{DO}(V_{IN})$	$V_{EN} > V_{EN(high)}$	$V_{BIAS} \geq V_{OUT} + V_{DO}(V_{BIAS})$	$I_{OUT} < I_{CL}$	$T_J < 125^{\circ}\text{C}$
Dropout mode	$V_{IN} < V_{OUT(nom)} + V_{DO}(V_{IN})$	$V_{EN} > V_{EN(high)}$	$V_{BIAS} < V_{OUT} + V_{DO}(V_{BIAS})$	—	$T_J < 125^{\circ}\text{C}$
Disabled mode (any true condition disables the device)		$V_{EN} < V_{EN(low)}$	$V_{BIAS} < V_{BIAS(UVLO)}$	—	$T_J > 165^{\circ}\text{C}$

6.4.1 Normal Operation

The device regulates to the nominal output voltage under the following conditions:

- The input voltage and bias voltage are both at least at the respective minimum specifications
- The enable voltage has previously exceeded the enable rising threshold voltage and has not decreased below the enable falling threshold
- The output current is less than the current limit
- The device junction temperature is less than the maximum specified junction temperature

6.4.2 Dropout Operation

If the input voltage is lower than the nominal output voltage plus the specified dropout voltage, but all other conditions are met for normal operation, the device operates in dropout mode. In this condition, the output voltage is the same as the input voltage minus the dropout voltage. The transient performance of the device is significantly degraded because the pass transistor is in a triode state and no longer controls the current through the LDO. Line or load transients in dropout can result in large output voltage deviations.

6.4.3 Disabled

The device is disabled under the following conditions:

- The input or bias voltages are below the respective minimum specifications
- The enable voltage is less than the enable falling threshold voltage or has not yet exceeded the enable rising threshold
- The device junction temperature is greater than the thermal shutdown temperature

7 Application and Implementation

备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

7.1 Application Information

7.1.1 Input, Output, and BIAS Capacitor Requirements

The device is designed to be stable for all available types of and values of output capacitors $\geq 2.2\mu\text{F}$. The device is also stable with multiple capacitors in parallel, which can be of any type or value.

The capacitance required on the IN and BIAS pin strongly depends on the input supply source impedance. To counteract any inductance in the input, the minimum recommended capacitor for V_{IN} and V_{BIAS} is $1\mu\text{F}$. If V_{IN} and V_{BIAS} are connected to the same supply, the recommended minimum capacitor for V_{BIAS} is $4.7\mu\text{F}$. Good quality, low-ESR capacitors must be used on the input; ceramic X5R and X7R capacitors are preferred. These capacitors must be placed as close as possible to the pins for optimum performance.

7.1.2 Transient Response

The TPS74901 is designed to have excellent transient response for most applications with a small amount of output capacitance. In some cases, the transient response can be limited by the transient response of the input supply. This limitation is especially true in applications where the difference between the input and output is less than 300mV. In this case, adding additional input capacitance improves the transient response much more than just adding additional output capacitance otherwise does. With a solid input supply, adding additional output capacitance reduces undershoot and overshoot during a transient event; see [图 5-36](#) in the [Typical Characteristics](#) section. Because the TPS74901 is stable with output capacitors as low as $2.2\mu\text{F}$, many applications can need very little capacitance at the LDO output. For these applications, local bypass capacitance for the powered device can be sufficient to meet the transient requirements of the application. This design reduces the total solution cost by avoiding the need to use expensive high-value capacitors at the LDO output.

7.1.3 Dropout Voltage

The TPS74901 offers very low dropout performance, making the device designed for high-current low V_{IN} and low V_{OUT} applications. The low dropout of the TPS74901 allows the device to be used in place of a DC/DC converter and still achieve good efficiencies. This capability provides designers with the power architecture for applications to achieve the smallest, simplest, and lowest-cost solution.

There are two different specifications for dropout voltage with the TPS74901. The first specification (see [图 7-1](#)) is referred to as $V_{\text{IN dropout}}$ and is used when an external bias voltage is applied to achieve low dropout. This specification assumes that V_{BIAS} is at least 3.25V above V_{OUT} , which is the case for V_{BIAS} when powered by a 5V rail with 5% tolerance and with $V_{\text{OUT}} = 1.5\text{V}$ (3.25V is a test condition of this device and can be adjusted by referring to [图 5-11](#)). If V_{BIAS} is higher than $V_{\text{OUT}} + 3.25\text{V}$, $V_{\text{IN dropout}}$ is less than specified.

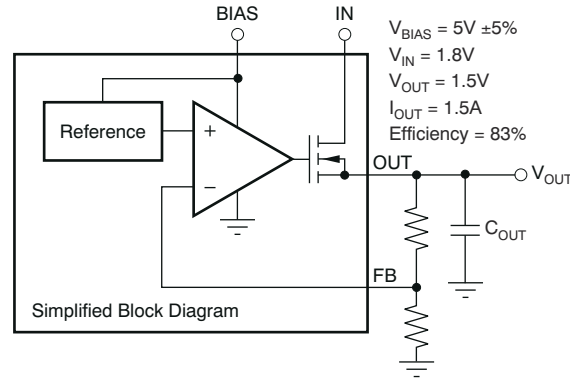


图 7-1. Typical Application of the TPS74901 Using an Auxiliary Bias Rail

The second specification (shown in 图 7-2) is referred to as V_{BIAS} dropout and is applied to applications where IN and BIAS are tied together. This option allows the device to be used in applications where an auxiliary bias voltage is not available or low dropout is not required. Dropout is limited by BIAS in these applications because V_{BIAS} provides the gate drive to the pass transistor; therefore, V_{BIAS} must be 1.75V above V_{OUT} . Because of this usage, IN and BIAS tied together easily consume a huge amount of power. Pay attention not to exceed the power rating of the device package.

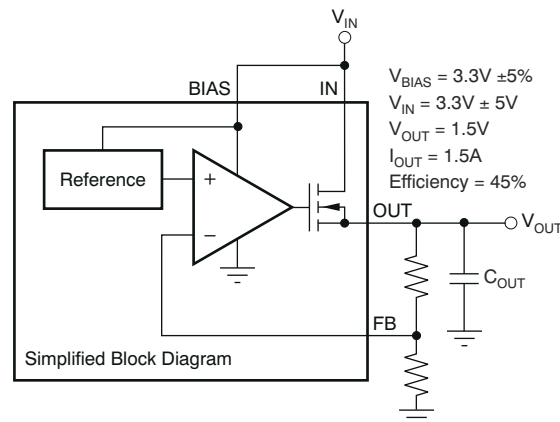


图 7-2. Typical Application of the TPS74901 Without an Auxiliary Bias

7.1.4 Output Noise

The TPS74901 provides low-output noise when a soft-start capacitor is used. When the device reaches the end of the soft-start cycle, the soft-start capacitor serves as a filter for the internal reference. By using a 0.001 μ F soft-start capacitor, the output noise is reduced by half and is typically 30 μ V_{RMS} for a 1.2V output (10Hz to 100kHz). Further increasing C_{SS} has little effect on noise. Because most of the output noise is generated by the internal reference, the noise is a function of the set output voltage. The RMS noise with a 0.001 μ F soft-start capacitor is given in 方程式 1.

$$V_N(\mu V_{RMS}) = 25 \left(\frac{\mu V_{RMS}}{V} \right) \times V_{OUT}(V) \quad (1)$$

The low-output noise of the TPS74901 makes the device a good choice for powering transceivers, PLLs, or other noise-sensitive circuitry.

7.1.5 Programmable Soft-Start

The TPS74901 features a programmable, monotonic, voltage-controlled soft-start that is set with an external capacitor (C_{SS}). This feature is important for many applications because power-up initialization problems are eliminated when powering FPGAs, DSPs, or other processors. The controlled voltage ramp of the output also reduces peak inrush current during start-up, minimizing start-up transient events to the input power bus.

To achieve a linear and monotonic soft-start, the TPS74901 error amplifier tracks the voltage ramp of the external soft-start capacitor until the voltage exceeds the internal reference. The soft-start ramp time is dependent on the soft-start charging current (I_{SS}), soft-start capacitance (C_{SS}), and the internal reference voltage (V_{REF}), and can be calculated using [方程式 2](#).

$$t_{SS} = \frac{(V_{REF} \times C_{SS})}{I_{SS}} \quad (2)$$

If large output capacitors are used, the device current limit (I_{CL}) and the output capacitor can set the start-up time. In this case, the start-up time is given by [方程式 3](#):

$$t_{SSCL} = \frac{(V_{OUT(NOM)} \times C_{OUT})}{I_{CL(MIN)}} \quad (3)$$

where:

- $V_{OUT(NOM)}$ is the nominal set output voltage
- C_{OUT} is the output capacitance
- $I_{CL(MIN)}$ is the minimum current limit for the device

In applications where monotonic start-up is required, the soft-start time given by [方程式 2](#) must be set to be greater than [方程式 3](#).

The maximum recommended soft-start capacitor is 0.015μF. Larger soft-start capacitors can be used and do not damage the device; however, the soft-start capacitor discharge circuit can possibly be unable to fully discharge the soft-start capacitor when enabled. Soft-start capacitors larger than 0.015μF can be a problem in applications where the enable pin must be rapidly pulsed while still requiring the device to soft-start from ground. C_{SS} must be low-leakage; X7R, X5R, or C0G dielectric materials are preferred. See [表 7-1](#) for suggested soft-start capacitor values.

表 7-1. Standard Capacitor Values for Programming the Soft-Start Time

$C_{SS}^{(1)}$	SOFT-START TIME (Legacy Chip)	SOFT-START TIME (New Chip)
Open	0.1ms	0.25ms
270pF	0.5ms	0.4ms
560pF	1ms	0.8ms
2.7nF	5ms	4.1ms
5.6nF	10ms	8.5ms
0.01μF	18ms	15ms

(1) $t_{SS}(s) = 0.8 \times C_{SS}(F) / I_{SS}$, where $t_{SS}(s)$ = soft-start time in seconds.

Another option for setting the start-up rate is to use a feedforward capacitor. See the [Pros and Cons of Using a Feedforward Capacitor with a Low-Dropout Regulator application note](#) for more information.

7.1.6 Sequencing Requirements

V_{IN} , V_{BIAS} , and V_{EN} can be sequenced in any order without causing damage to the device. However, for the soft-start function to work as intended, certain sequencing rules must be applied. Connecting EN to IN is acceptable for most applications as long as V_{IN} is greater than 1.1V, and the ramp rate of V_{IN} and V_{BIAS} is faster than the set soft-start ramp rate. If the ramp rate of the input sources is slower than the set soft-start time, the output tracks the slower supply minus the dropout voltage until the set output voltage is reached. If EN is connected to BIAS, the device soft-starts as programmed, provided that V_{IN} is present before V_{BIAS} . If V_{BIAS} and V_{EN} are present before V_{IN} is applied and the set soft-start time has expired, then V_{OUT} tracks V_{IN} . If the soft-start time has not expired, the output tracks V_{IN} until V_{OUT} reaches the value set by the charging soft-start capacitor. 图 7-3 shows the use of an RC delay circuit to hold off V_{EN} until V_{BIAS} has ramped. This technique can also be used to drive EN from V_{IN} . An external control signal can also be used to enable the device after V_{IN} and V_{BIAS} are present.

备注

When V_{BIAS} and V_{EN} are present and V_{IN} is not supplied, this device outputs approximately 50 μ A of current from OUT. Although this condition does not cause any damage to the device, the output current can charge up the OUT node if total resistance between OUT and GND (including external feedback resistors) is greater than 10k Ω .

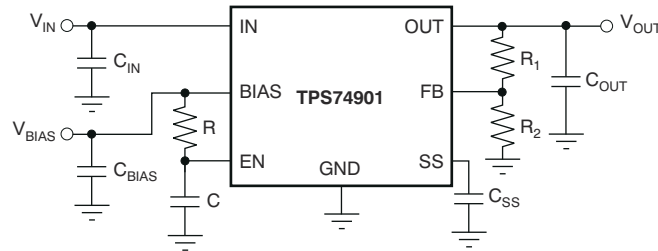


图 7-3. Soft-Start Delay Using an RC Circuit on Enable

7.2 Typical Application

图 7-4 shows the typical application circuit for the TPS74901 adjustable output device.

R_1 and R_2 can be calculated for any output voltage using the formula shown in 图 7-4. 表 7-2 lists sample resistor values of common output voltages. To achieve the maximum accuracy specifications, R_2 must be $\leq 4.99\text{k}\Omega$.

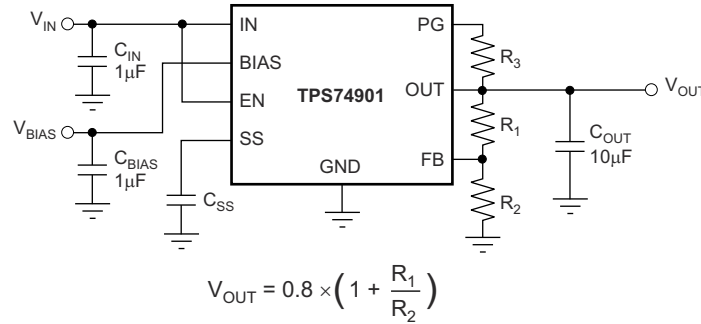


图 7-4. Typical Application Circuit for the TPS74901 (Adjustable)

表 7-2. Standard 1% Resistor Values for Programming the Output Voltage ⁽¹⁾

R_1 (k Ω)	R_2 (k Ω)	V_{OUT} (V)
Short	Open	0.8
0.619	4.99	0.9
1.13	4.53	1
1.37	4.42	1.05
1.87	4.99	1.1
2.49	4.99	1.2
4.12	4.75	1.5
3.57	2.87	1.8
3.57	1.69	2.5
3.57	1.15	3.3

(1) $V_{OUT} = 0.8 \times (1 + R_1 / R_2)$.

7.2.1 Design Requirements

The goal of this design is to create a 1.2V rail at 3A with minimal external components from a 1.5V rail.

7.2.2 Detailed Design Procedure

First choose the bias, which must be at least 1.75V above the output voltage. A 3.3V rail is used to achieve this minimum voltage. For a minimal external component count and size, select the minimum capacitor sizes. $C_{IN} = 1\mu\text{F}$, $C_{BIAS} = 1\mu\text{F}$, and a $C_{OUT} = 10\mu\text{F}$. The C_{OUT} value was chosen to improve transient response. Using 表 7-2, R_1 is set to 2.49k Ω and R_2 is set to 4.99k Ω to create a 1.2V rail. The pullup resistor for PG is set to 10k Ω .

7.2.3 Application Curves

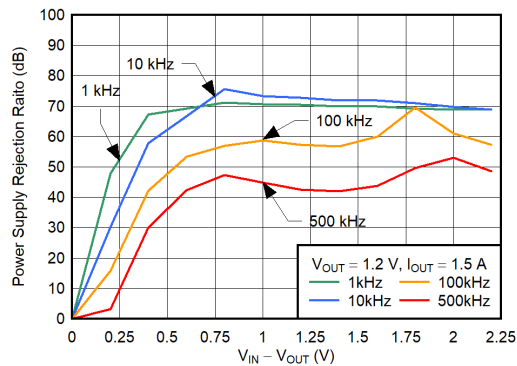


图 7-5. V_{IN} PSRR vs ($V_{IN} - V_{OUT}$)

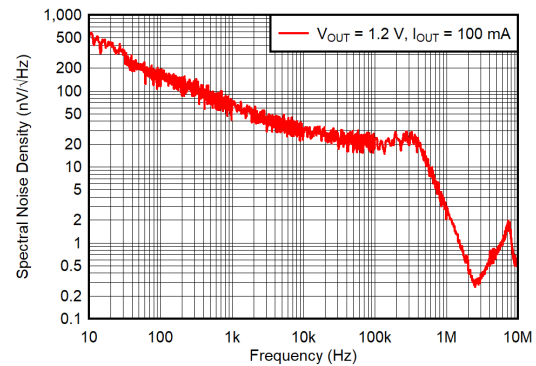


图 7-6. Noise Spectral Density

7.3 Power Supply Recommendations

The TPS74901 is designed to operate from an input voltage from 1.1V to 5.5V, provided the bias rail is at least 1.75V higher than the input supply. The bias rail and the input supply must both provide adequate headroom and current for the device to operate normally.

Connect a low-output impedance power supply directly to the IN pin of the TPS74901. This supply must have at least 1μF of capacitance near the IN pin for stability. A supply with similar requirements must also be connected directly to the bias rail with a separate 1μF or larger capacitor.

If the IN pin is tied to the bias pin, a minimum 4.7μF of capacitance is needed for stability.

To increase the overall PSRR of the solution at higher frequencies, use a PI-filter or ferrite bead before the input capacitor.

7.4 Layout

7.4.1 Layout Guidelines

An optimal layout can greatly improve transient performance, PSRR, and noise. To minimize the voltage droop on the input of the device during load transients, connect the capacitance on IN and BIAS as close as possible to the device. This capacitance also minimizes the effects of parasitic inductance and resistance of the input source and can therefore improve stability. To achieve optimal transient performance and accuracy, connect the top side of R_1 in 图 7-4 as close as possible to the load. If BIAS is connected to IN, connect BIAS as close to the sense point of the input supply as possible. This connection minimizes the voltage droop on BIAS during transient conditions and can improve the turn-on response.

7.4.1.1 Power Dissipation

Knowing the device power dissipation and proper sizing of the thermal plane that is connected to the tab or pad is critical to avoiding thermal shutdown and ensuring reliable operation.

Power dissipation of the device depends on input voltage and load conditions, and can be calculated using 方程 式 4:

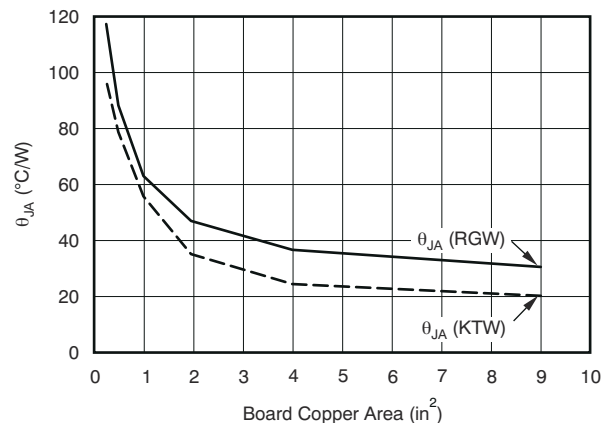
$$P_D = (V_{IN} - V_{OUT}) \times I_{OUT} \quad (4)$$

Power dissipation can be minimized and greater efficiency can be achieved by using the lowest possible input voltage necessary to achieve the required output voltage regulation.

On the VQFN (RGW) package, the primary conduction path for heat is through the exposed pad to the PCB. The pad can be connected to ground or left floating; however, the pad must be attached to an appropriate amount of copper PCB area to ensure the device does not overheat. On the DDPAK (KTW) package, the primary conduction path for heat is through the tab to the PCB. Connect that tab to ground. The maximum junction-to-ambient thermal resistance depends on the maximum ambient temperature, maximum device junction temperature, and power dissipation of the device and can be estimated using 方程式 5:

$$R_{\theta JA} = \frac{(+125^{\circ}\text{C} - T_A)}{P_D} \quad (5)$$

Knowing the maximum $R_{\theta JA}$, the minimum amount of PCB copper area needed for appropriate heat sinking can be estimated using 图 7-7.



$R_{\theta JA}$ value at board size of 9 in² (that is, 3 inches × 3 inches) is a JEDEC standard.

图 7-7. $R_{\theta JA}$ versus Board Size

图 7-7 shows the variation of $R_{\theta JA}$ as a function of ground plane copper area in the board. 图 7-7 is intended only as a guideline to demonstrate the affects of heat spreading in the ground plane; do not use 图 7-7 to estimate actual thermal performance in real application environments.

备注

When the device is mounted on an application PCB, TI strongly recommends using Ψ_{JT} and Ψ_{JB} , as explained in the [Thermal Considerations](#) section.

7.4.1.2 Thermal Considerations

A better method of estimating the thermal measure comes from using the thermal metrics Ψ_{JT} and Ψ_{JB} , as shown in 方程式 6. These metrics are a more accurate representation of the heat transfer characteristics of the die and the package than $R_{\theta JA}$. The junction temperature can be estimated with the corresponding formulas given in 方程式 6.

$$\begin{aligned} \Psi_{JT}: T_J &= T_T + \Psi_{JT} \cdot P_D \\ \Psi_{JB}: T_J &= T_B + \Psi_{JB} \cdot P_D \end{aligned} \quad (6)$$

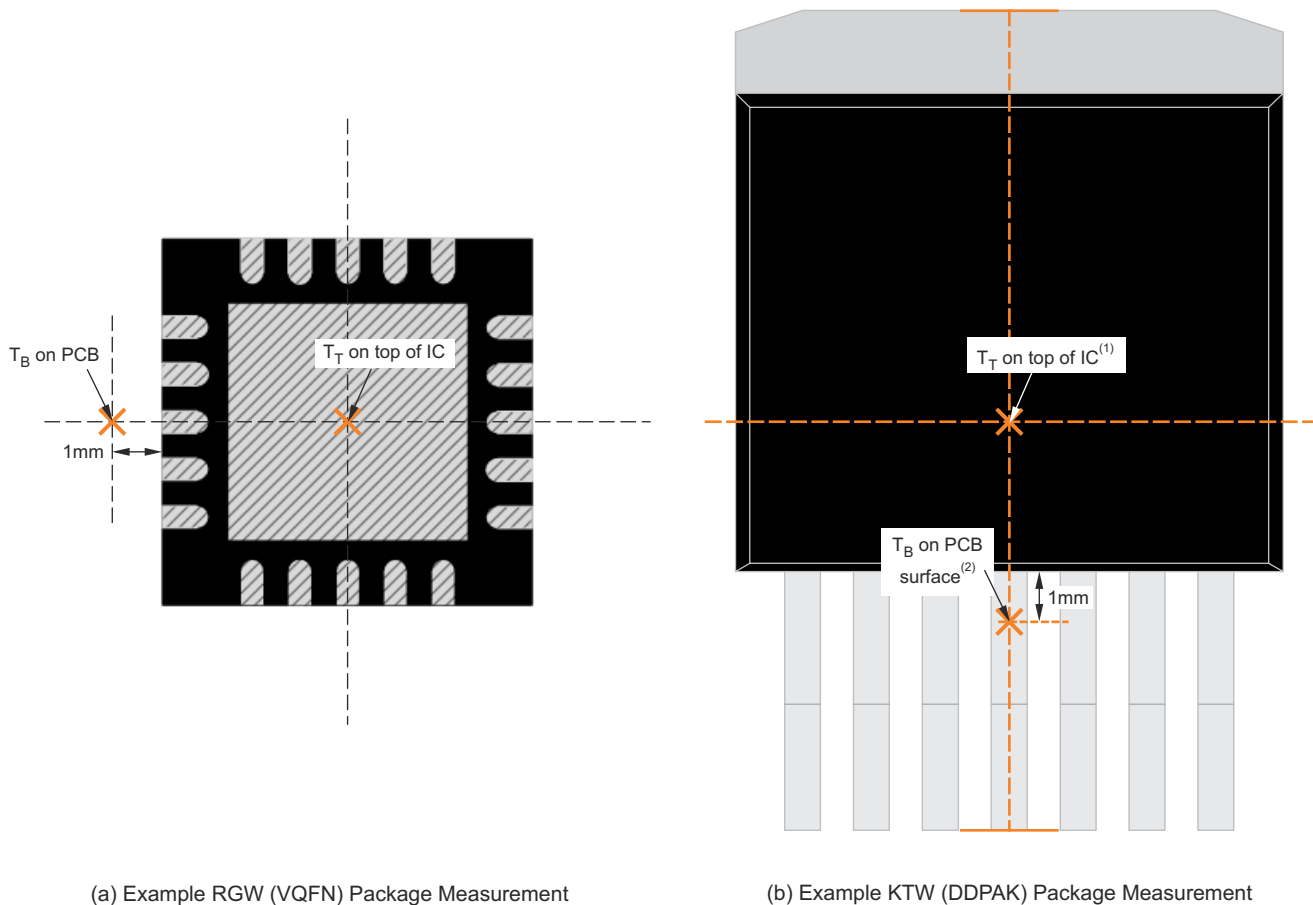
where:

- P_D is the power dissipation shown by 方程式 4
- T_T is the temperature at the center-top of the device package
- T_B is the PCB temperature measured 1mm away from the device package *on the PCB surface* (see 图 7-8)

备注

Both T_T and T_B can be measured on actual application boards using a thermo-gun (an infrared thermometer).

For more information about measuring T_T and T_B , see the [Using New Thermal Metrics](#) application note, available for download at www.ti.com.



- A. T_T is measured at the center of both the X- and Y-dimensional axes.
- B. T_B is measured below the package lead on the PCB surface.

图 7-8. Measuring Points for T_T and T_B

Compared with $R_{\theta JA}$, the thermal metrics Ψ_{JT} and Ψ_{JB} are less independent of board size but do have a small dependency on board size and layout. 图 7-9 shows characteristic performance of Ψ_{JT} and Ψ_{JB} versus board size.

Referring to 图 7-9, the RGW package thermal performance has negligible dependency on board size. The KTW package, however, does have a measurable dependency on board size. This dependency exists because the package shape is not point symmetric to the center of a device. In the KTW package, for example (see 图 7-8), silicon is not beneath the measuring point of T_T that is the center of the X and Y dimension, so that Ψ_{JT} has a dependency. Also, because of that non-point symmetry, device heat distribution on the PCB is not point symmetric either, so that Ψ_{JB} has a greater dependency on board size and layout.

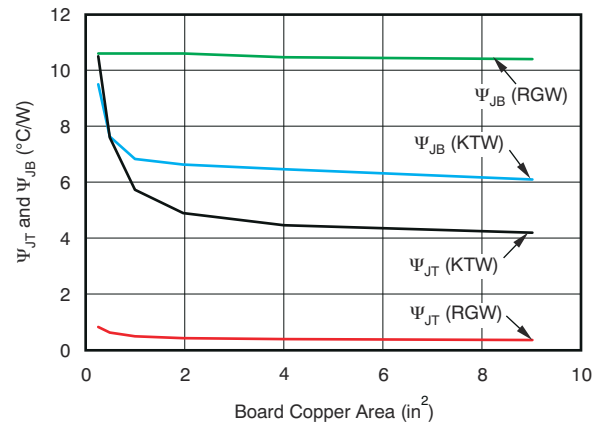


图 7-9. Ψ_{JT} 和 Ψ_{JB} versus Board Size

For a more detailed discussion of why TI does not recommend using $R_{\theta JC(top)}$ to determine thermal characteristics, see the [Using New Thermal Metrics application note](#), available for download at www.ti.com. Also, see the [IC Package Thermal Metrics application note](#) (also available on the TI website) for further information.

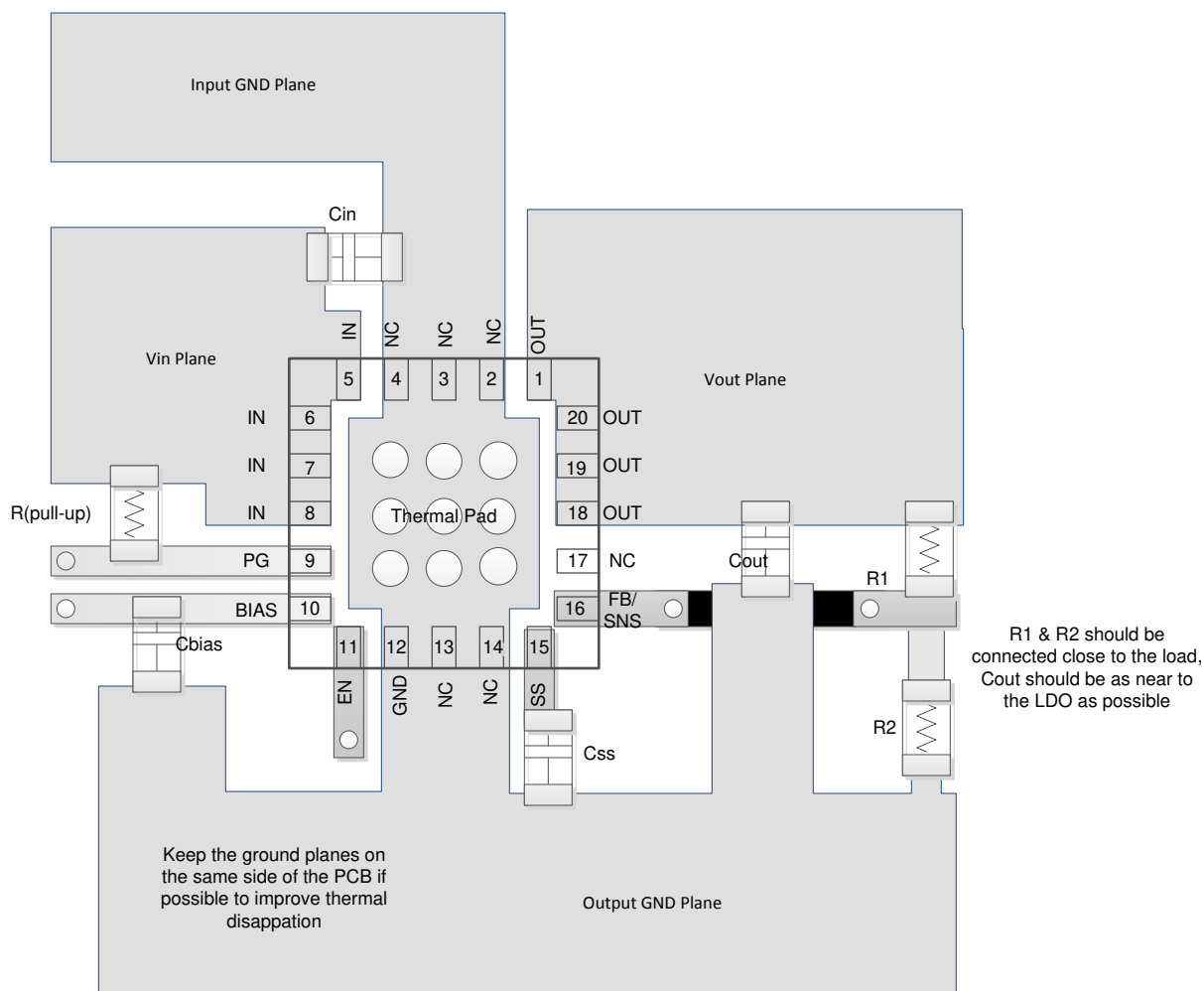


图 7-10. Layout Schematic (RGW Package)

8 Device and Documentation Support

8.1 Device Support

8.1.1 Device Nomenclature

表 8-1. Device Nomenclature

PRODUCT ⁽¹⁾	V _{OUT}
TPS74901yyyzM3	<p>yyy is the package designator. z is the package quantity. M3 is a suffix designator for devices that only use the latest manufacturing flow (CSO: RFB). Devices without this suffix ship with the legacy chip (CSO: DLN) or the new chip (CSO: RFB). The reel packaging label provides CSO information to distinguish which chip is used. The device performance for new and legacy chips is denoted throughout the document.</p>

(1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or visit the device product folder on www.ti.com.

8.1.2 Development Support

8.1.2.1 Evaluation Modules

An evaluation module (EVM) is available to assist in the initial circuit performance evaluation using the TPS74901. The [TPS74901EVM-210 evaluation module](#) and related user's guide ([SLVU190](#)) can be requested at the Texas Instruments website through the product folders or purchased directly from the [TI eStore](#).

8.1.2.2 Spice Models

Computer simulation of circuit performance using SPICE is often useful when analyzing the performance of analog circuits and systems. A SPICE model for the TPS74901 is available through the product folders under *Tools & Software*.

8.2 Documentation Support

8.2.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [Using New Thermal Metrics applicatin note](#)
- Texas Instruments, [Semiconductor and IC Package Thermal Metrics application note](#)
- Texas Instruments, [Ultimate Regulation with Fixed Output Version of TPS742xx/TPS743xx/TPS744xx application note](#)
- Texas Instruments, [Pros and Cons of Using a Feed-Forward Capacitor with a Low Dropout Regulator application note](#)
- Texas Instruments, [TPS74901EVM-210 user's guide](#)

8.3 接收文档更新通知

要接收文档更新通知，请导航至 ti.com 上的器件产品文件夹。点击 [通知](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

8.4 支持资源

[TI E2E™ 中文支持论坛](#) 是工程师的重要参考资料，可直接从专家处获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题，获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的 [使用条款](#)。

8.5 Trademarks

TI E2E™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

8.6 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

8.7 术语表

TI 术语表 本术语表列出并解释了术语、首字母缩略词和定义。

9 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision J (April 2023) to Revision K (June 2024)	Page
• 将 M3 引用更改为新芯片在说明部分中添加了整个线路、负载和温度范围内的精度：1% (新芯片)	1
• Added (Legacy Chip) to KTW package.....	3
• Changed <i>Typical Characteristics: $I_{OUT} = 50mA$</i> section and added new chip curves.....	8
• Changed <i>Typical Characteristics: $I_{OUT} = 1 A$</i> section, added new chip curves side by side to legacy curves..	14
• Changed <i>Legacy Chip Functional Block Diagram</i> to include pulldown resistor for legacy chip and added <i>New Chip Functional Block Diagram</i>	16
• Added active pulldown circuit discussion and equation to <i>Enable and Shutdown</i> section.....	17
• Added <i>SOFT-START TIME (New Chip)</i> column and changed footnote in <i>Standard Capacitor Values for Programming the Soft-Start Time</i> table.....	22
• Added feed-forward capacitor discussion to <i>Programmable Soft-Start</i> section.....	22
• Changed <i>Application Curves</i> section to only show new chip curves.....	25
• Changed last sentence of <i>Layout Recommendations and Power Dissipation</i> section; added 图 7-7	25
• Deleted (previously numbered) Figure 35 through Figure 39.....	26
• Added <i>Device Nomenclature</i> section.....	30

Changes from Revision I (May 2016) to Revision J (April 2023)	Page
• 更新了整个文档中的表格、图和交叉参考的编号格式	1
• 向文档添加了 M3 后缀器件.....	1
• 添加了指向应用部分的链接.....	1

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TPS74901DRCR	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	11S
TPS74901DRCR.A	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	11S
TPS74901DRCRG4	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	11S
TPS74901DRCRG4.A	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	11S
TPS74901DRCRM3	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	11S
TPS74901DRCRM3.A	Active	Production	VSON (DRC) 10	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	11S
TPS74901DRCT	Active	Production	VSON (DRC) 10	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	11S
TPS74901DRCT.A	Active	Production	VSON (DRC) 10	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	11S
TPS74901KTWR	Active	Production	DDPAK/TO-263 (KTW) 7	500 LARGE T&R	Yes	Call TI Sn	Level-2-260C-1 YEAR	-40 to 125	TPS74901
TPS74901KTWR.A	Active	Production	DDPAK/TO-263 (KTW) 7	500 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	TPS74901
TPS74901RGWR	Active	Production	VQFN (RGW) 20	3000 LARGE T&R	Yes	NIPDAU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TPS 74901
TPS74901RGWR.A	Active	Production	VQFN (RGW) 20	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TPS 74901
TPS74901RGWRM3	Active	Production	VQFN (RGW) 20	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TPS 74901
TPS74901RGWRM3.A	Active	Production	VQFN (RGW) 20	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TPS 74901
TPS74901RGWT	Active	Production	VQFN (RGW) 20	250 SMALL T&R	Yes	NIPDAU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TPS 74901
TPS74901RGWT.A	Active	Production	VQFN (RGW) 20	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TPS 74901
TPS74901RGWTG4	Active	Production	VQFN (RGW) 20	250 SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TPS 74901

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS74901DRCR	VSON	DRC	10	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS74901DRCRG4	VSON	DRC	10	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS74901DRCRM3	VSON	DRC	10	3000	330.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS74901DRCT	VSON	DRC	10	250	180.0	12.4	3.3	3.3	1.1	8.0	12.0	Q2
TPS74901RGWR	VQFN	RGW	20	3000	330.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2
TPS74901RGWRM3	VQFN	RGW	20	3000	330.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2
TPS74901RGWT	VQFN	RGW	20	250	180.0	12.4	5.3	5.3	1.1	8.0	12.0	Q2

TAPE AND REEL BOX DIMENSIONS

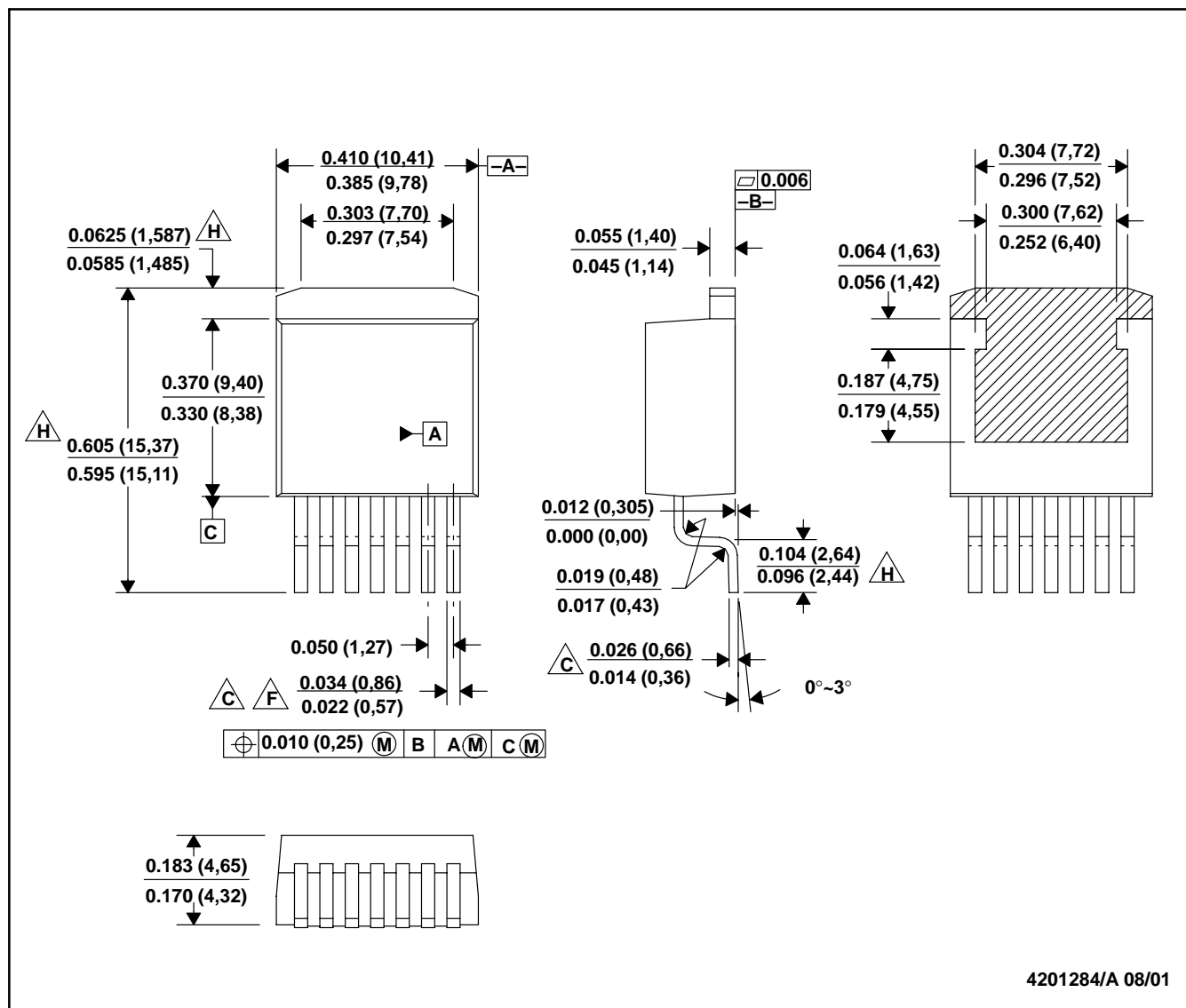


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS74901DRCR	VSON	DRC	10	3000	367.0	367.0	35.0
TPS74901DRCRG4	VSON	DRC	10	3000	367.0	367.0	35.0
TPS74901DRCRM3	VSON	DRC	10	3000	367.0	367.0	35.0
TPS74901DRCT	VSON	DRC	10	250	210.0	185.0	35.0
TPS74901RGWR	VQFN	RGW	20	3000	367.0	367.0	35.0
TPS74901RGWRM3	VQFN	RGW	20	3000	367.0	367.0	35.0
TPS74901RGWT	VQFN	RGW	20	250	210.0	185.0	35.0

KTW (R-PSFM-G7)

PLASTIC FLANGE-MOUNT



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Lead width and height dimensions apply to the plated lead.
 - D. Leads are not allowed above the Datum B.
 - E. Stand-off height is measured from lead tip with reference to Datum B.
 - F. Lead width dimension does not include dambar protrusion. Allowable dambar protrusion shall not cause the lead width to exceed the maximum dimension by more than 0.003".
 - G. Cross-hatch indicates exposed metal surface.
 - H. Falls within JEDEC MO-169 with the exception of the dimensions indicated.

GENERIC PACKAGE VIEW

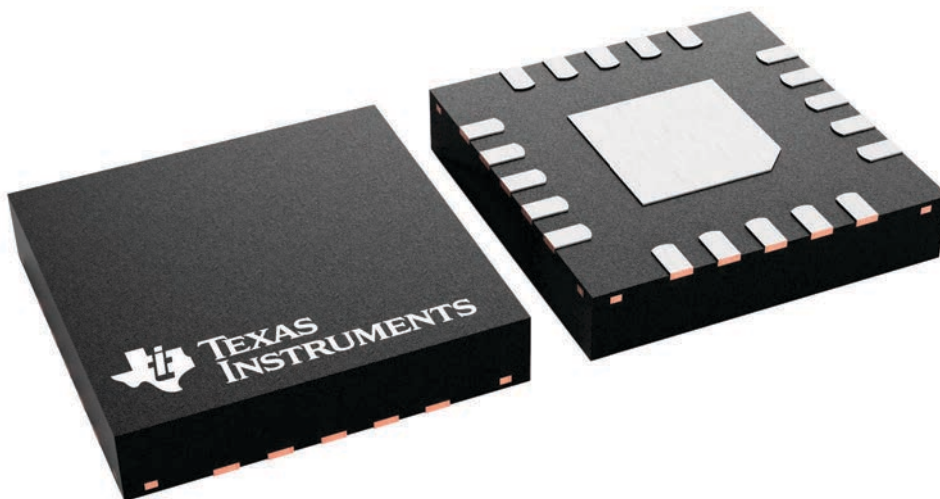
RGW 20

VQFN - 1 mm max height

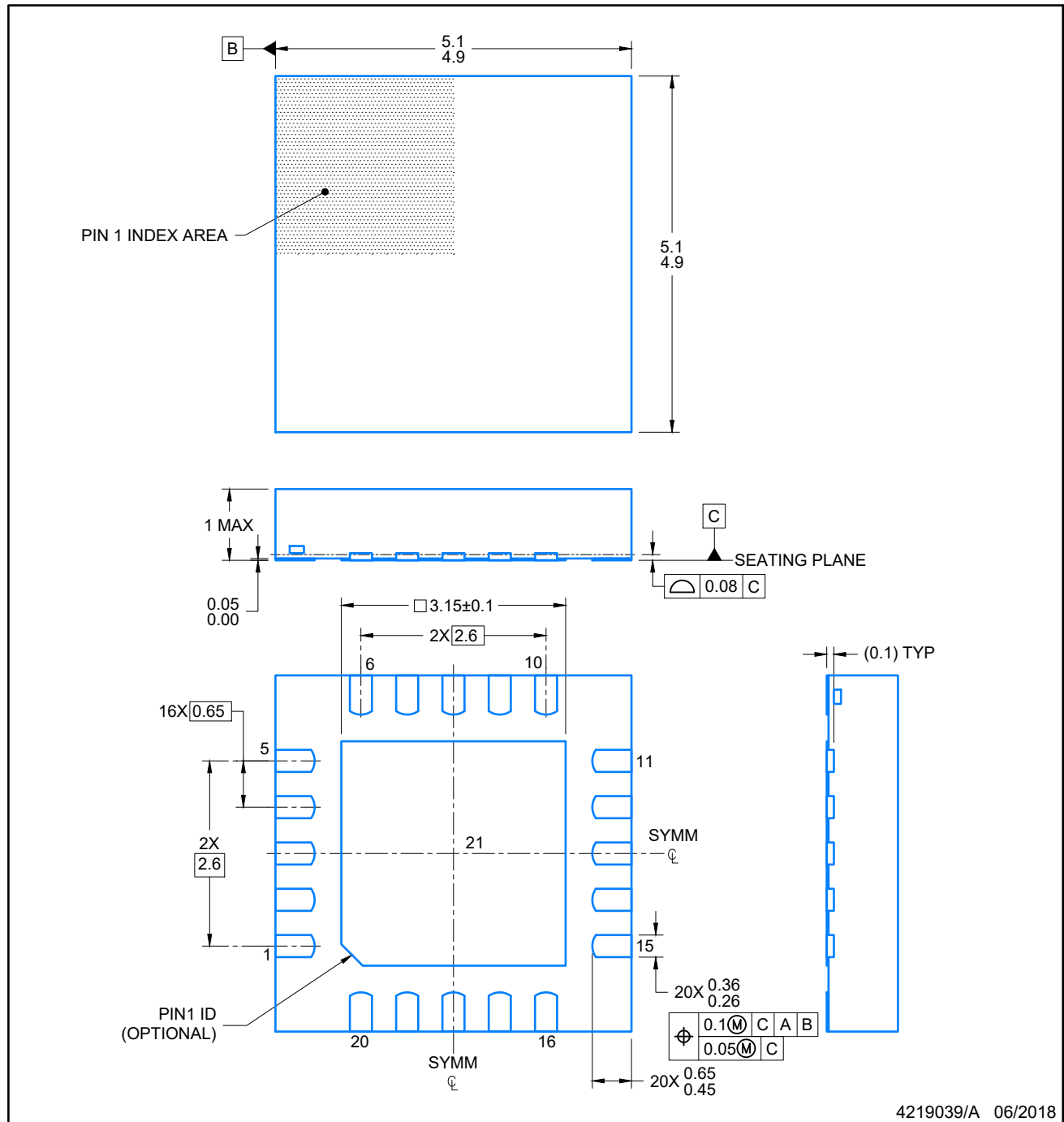
5 x 5, 0.65 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

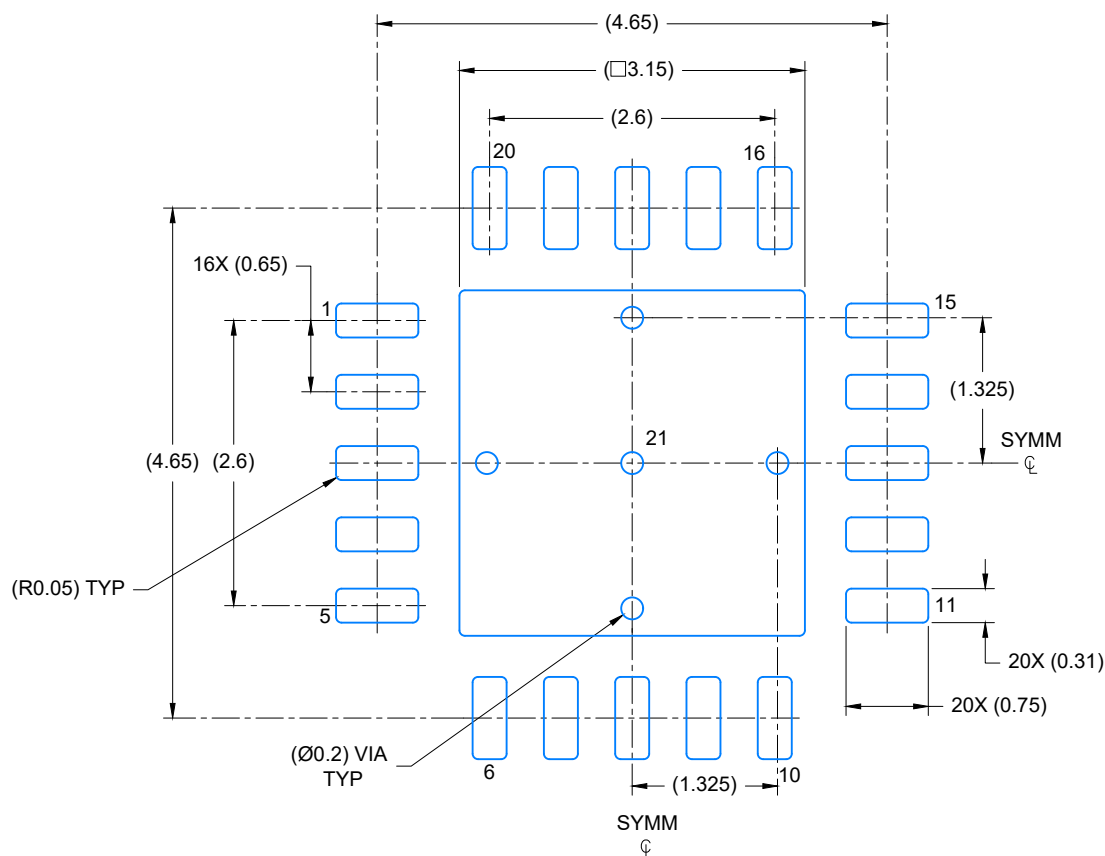


4227157/A



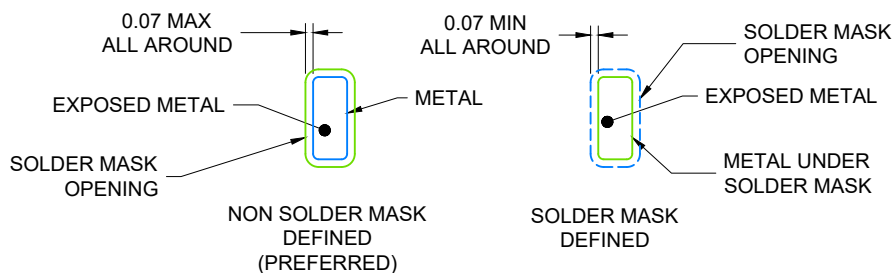
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



LAND PATTERN EXAMPLE

SCALE: 15X



SOLDER MASK DETAILS

4219039/A 06/2018

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

PLASTIC QUAD FLATPACK-NO LEAD

GENERIC PACKAGE VIEW

DRC 10

VSON - 1 mm max height

3 x 3, 0.5 mm pitch

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.





4218878/B 07/2018

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

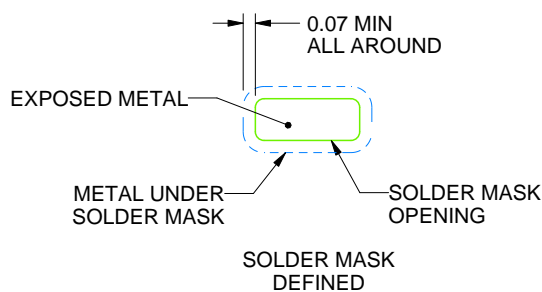
DRC0010J

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:20X



SOLDER MASK DETAILS

4218878/B 07/2018

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

DRC0010J

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 11:
80% PRINTED SOLDER COVERAGE BY AREA
SCALE:25X

4218878/B 07/2018

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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